

# Nuclei identification using deep learning for AMS Tracker

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# Introduction

- In many experiments, deep learning has shown it can go beyond traditional methods, enabling the full exploitation of detector capabilities.
- In AMS, deep learning can be applied to many tasks, such as nuclei and charge identification, background estimation, charge reconstruction, rigidity reconstruction, unfolding, and more.
- In this study, we take a nuclei identification task for Silicon as an attempt to explore the application of deep learning to the AMS tracker detector using MC, providing an initial look at its potential.
- A future study using Data will build on this to address discrepancy between Data and MC.

# Samples and Task

## Samples:

- L1Inner MC: Mg, Al, Si, P, S
- from NAIA Version v1.1.1

## Input variables:

- Tracker ADC (with Beta correction) and seed strip address:
  - the seed ADC of 10 clusters for each layer and side (**in Edep descending order**)
  - the 2 adjacent strip (left and right) ADC of the first 3 clusters for each layer and side
- TOF unbiased Beta ( $1/\beta^2$ )

## **Task : Signal background discrimination (with MC samples only for now)**

- **Signal:** primary Si survived below L2
- **Background 1:** primary Si survived above L2
- **Background 2:** other nuclei (Mg, Al, P, S)

# Event selection

**Event selection for Mg, Al, Si, P, S** (L1Inner selection without tracker charge and fiducial volume cuts):

- Upper TOF selection
  - TrTrack selection
  - $\text{InnerNHitY} \geq 5 \ \&\& \ L2 \& (L3|L4) \& (L5|L6) \& (L7|L8)$
  - $\text{InnerNormChisqY} < 10$
  - $\text{L1InnerNormChisqY} < 10 \ \&\& \ \text{L1InnerChisqY} - \text{InnerChisqY} < 10$  (for L1Inner analysis)
- + **Primary particle survived on L1 (using MC truth information)**

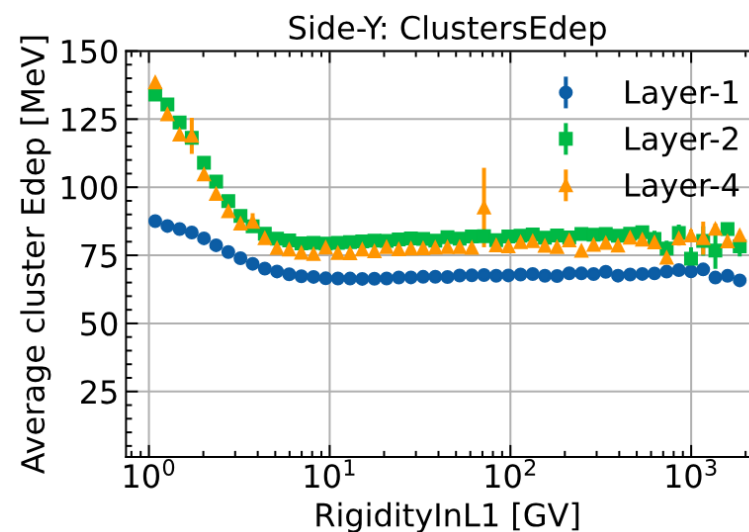
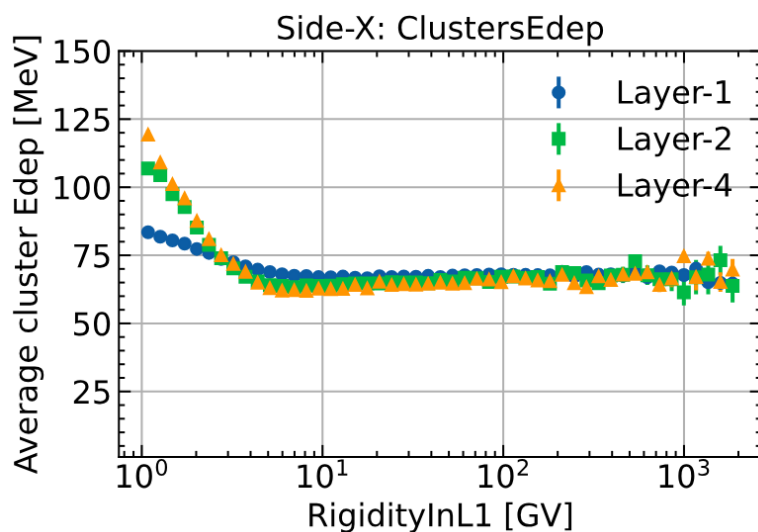
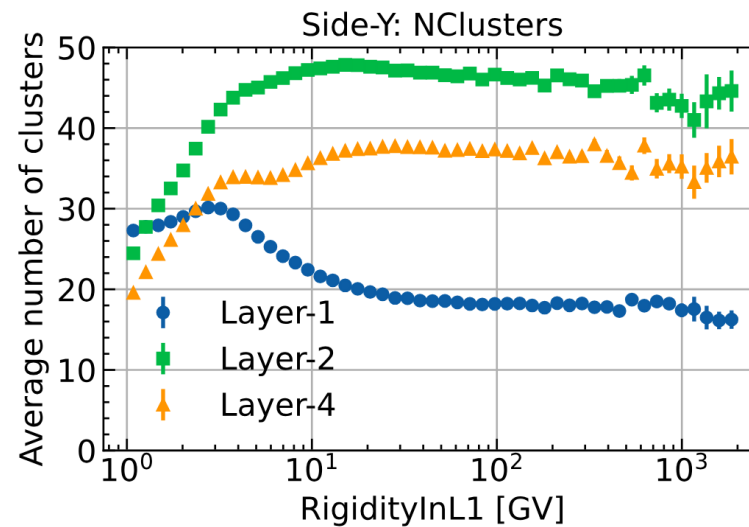
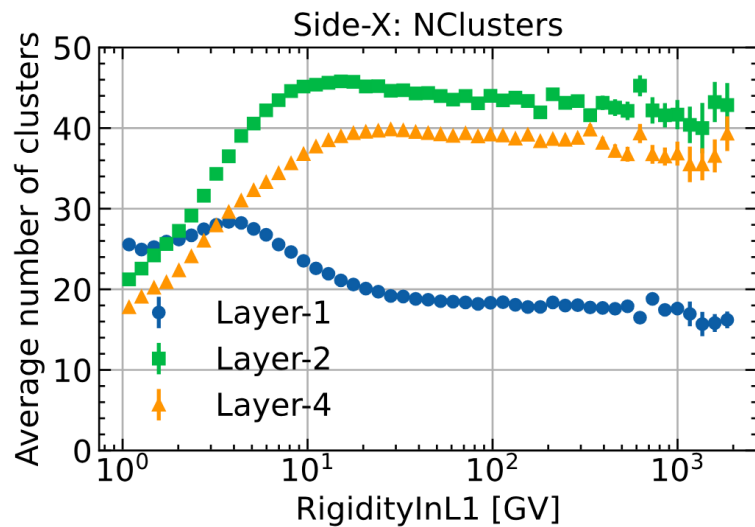
**Selected samples** (300k events for each categories):

- Signal: primary Si survived below L2
- Background 1: primary Si survived above L2
- Background 2: background nuclei (Mg, Al, P, S = 0.1 : 1 : 1 : 0.1)

Sample is divided into 80% for model training and 20% for testing

1. Check input variables

# Clusters on each layer (Fe L1Inner selection with L1 and Inner Tracker Charge > 25.5)



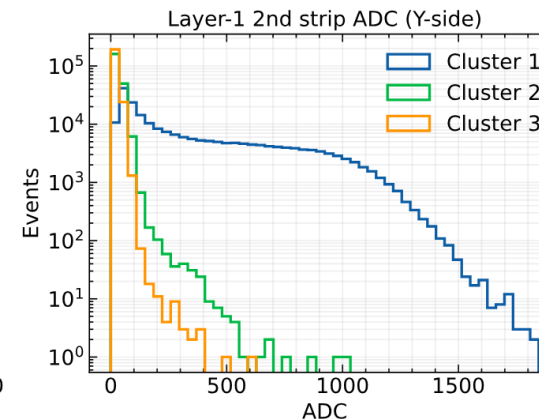
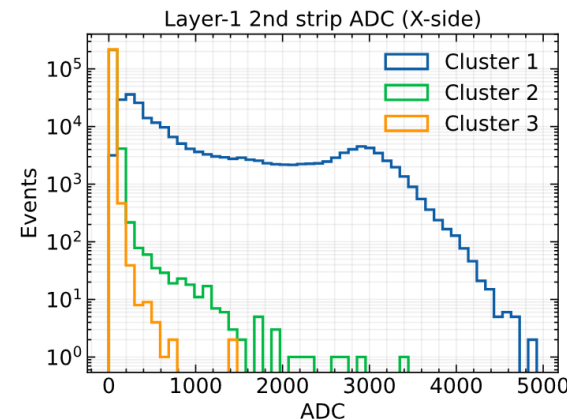
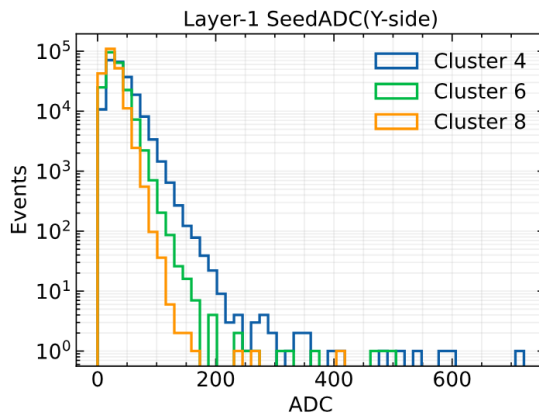
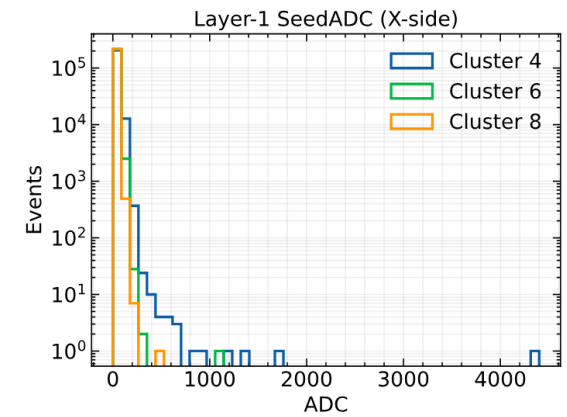
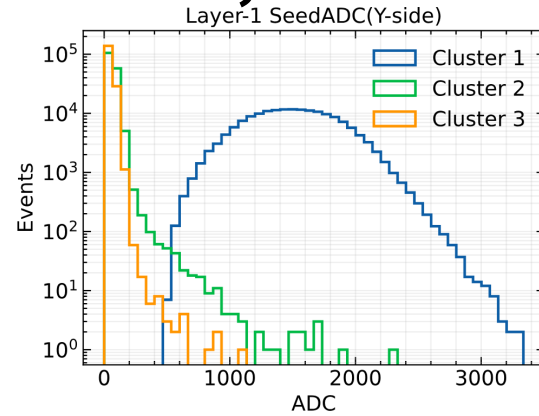
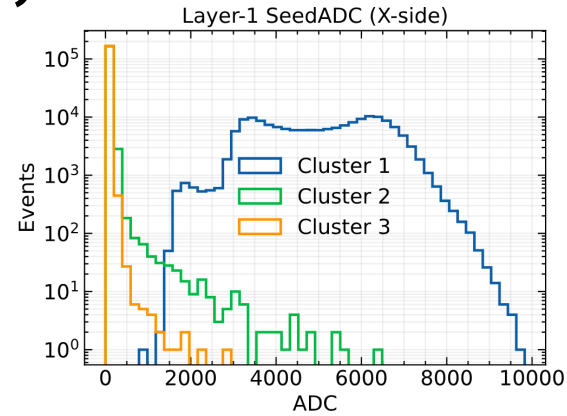
(Plots from my slides about Event Size Assessment for Supporting L0 DAQ Scheme Development.)

# ADC Values (Sulfur MC, L1 Inner selection, 200K events)

- Clusters are arranged in Edep descending order.
- ADC: with Beta correction.
- ☑ Seed strip of the max cluster has much higher ADC value than the others.
- ☑ For max ADC value: 2nd strip of cluster-1  $\approx$  seed strip of cluster-2
- ☑ Similar for the other layers (in backup slides)

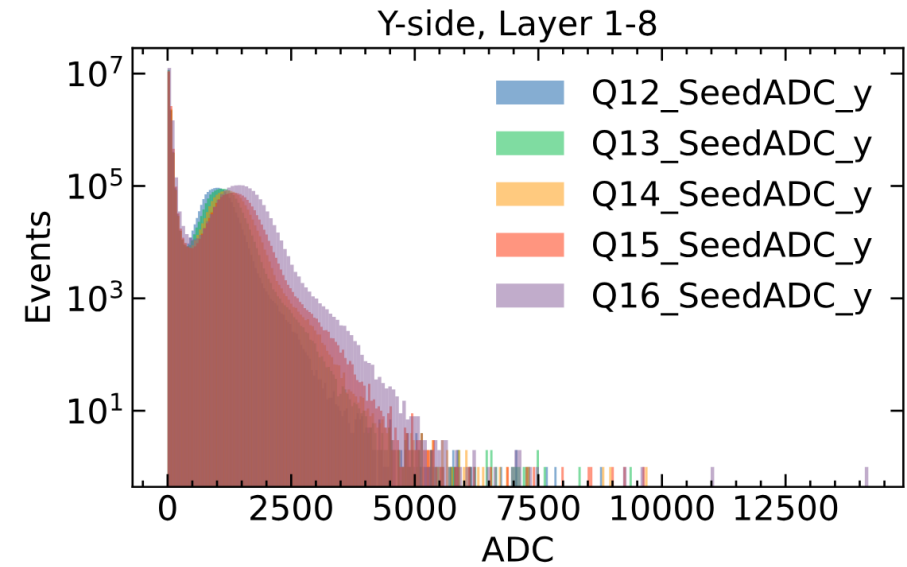
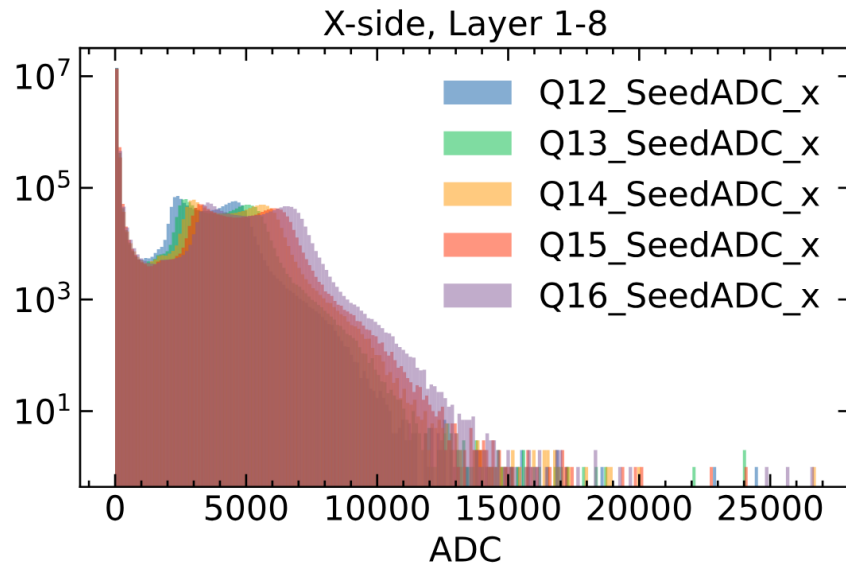
For deep learning input:

- the seed ADC of the first 10 clusters for each layer and side
- the 2 adjacent strip (left and right) ADC of the first 3 clusters for each layer and side

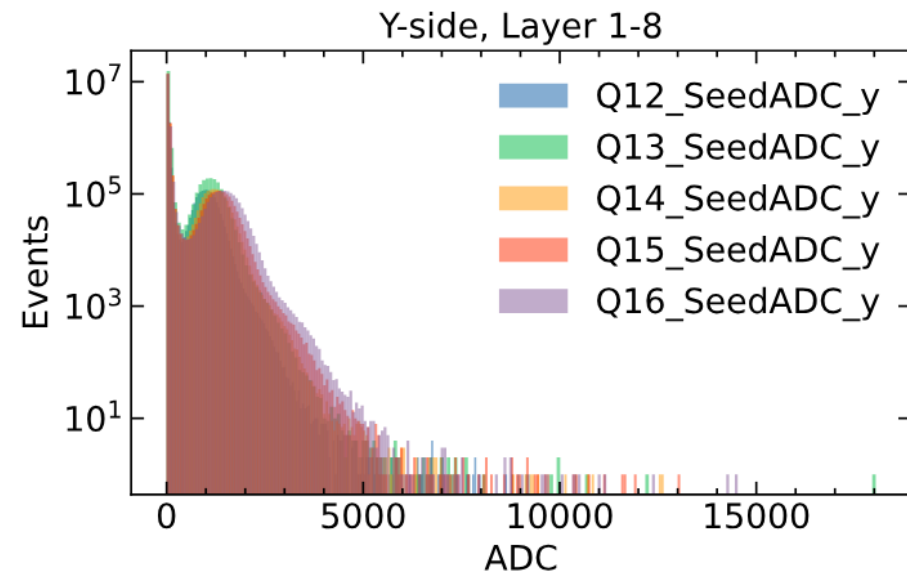
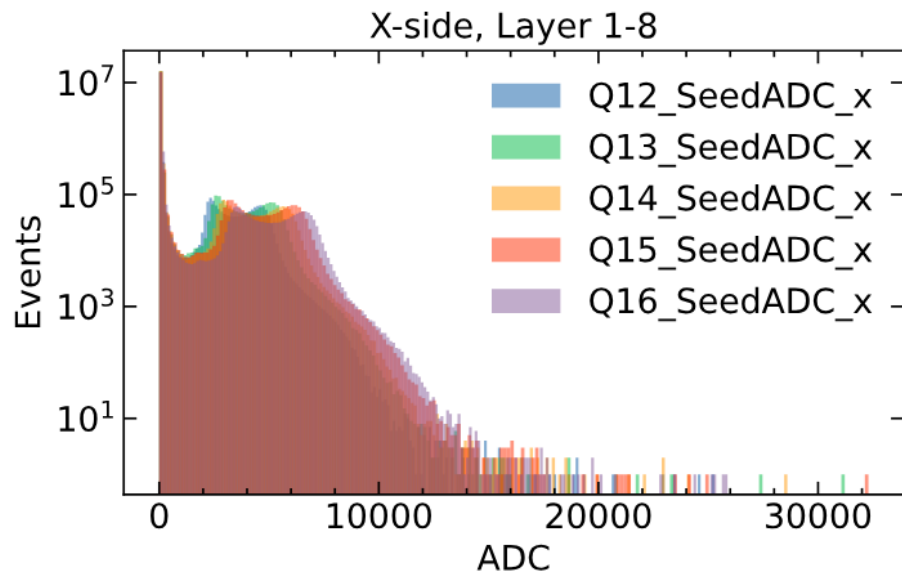


# ADC distributions for Al, Mg, Si, P, S (MC, L1Inner selection)

ADC without correction



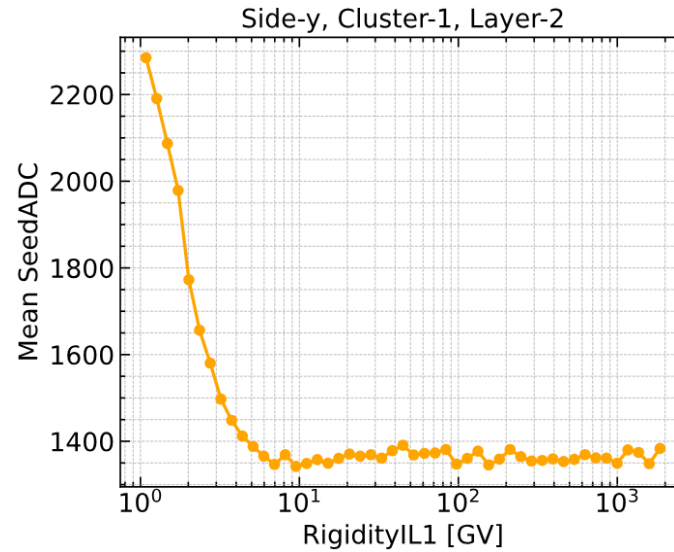
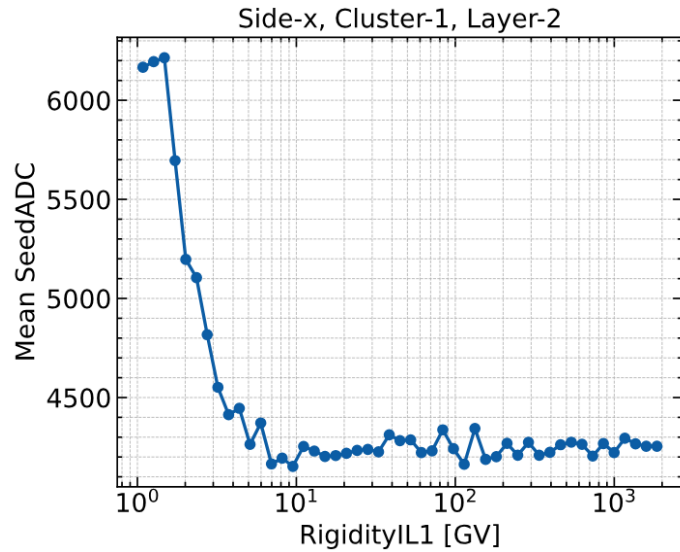
ADC with Beta correction  
(kBeta from AMS software)





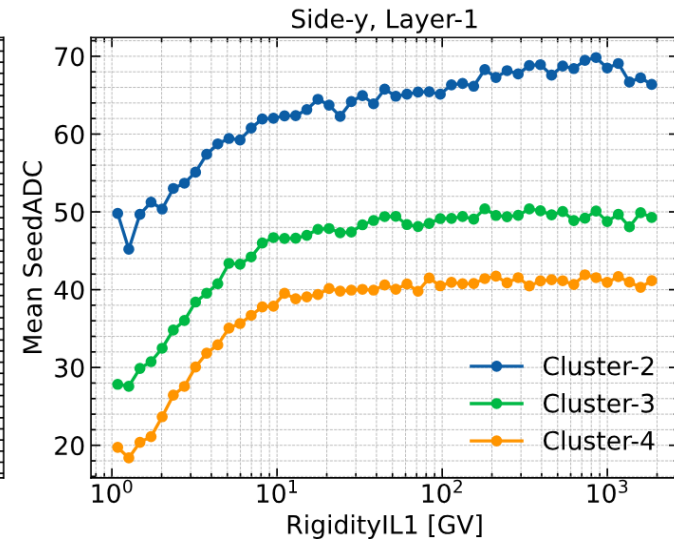
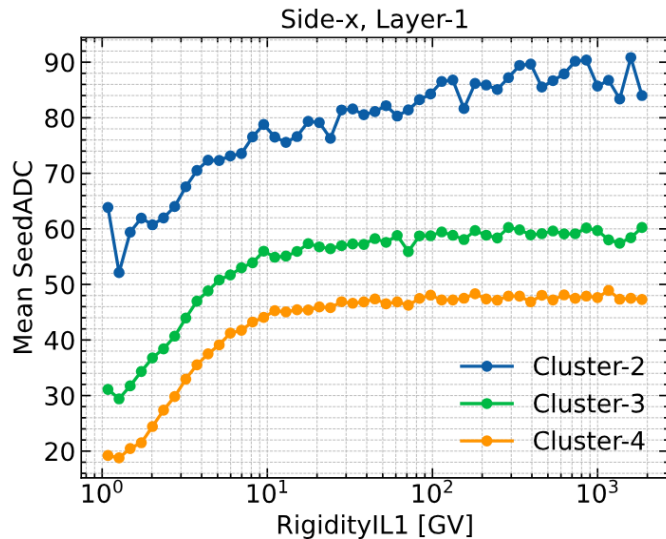
# Rigidity dependence of ADC with Beta correction (Sulfur MC, L1Inner selection, 200K events)

Mean seed ADC  
of max Edep  
clusters:



**Further Beta correction is needed.**  
→ Add TOF Beta information to the deep learning models

Mean seed ADC  
of other clusters:

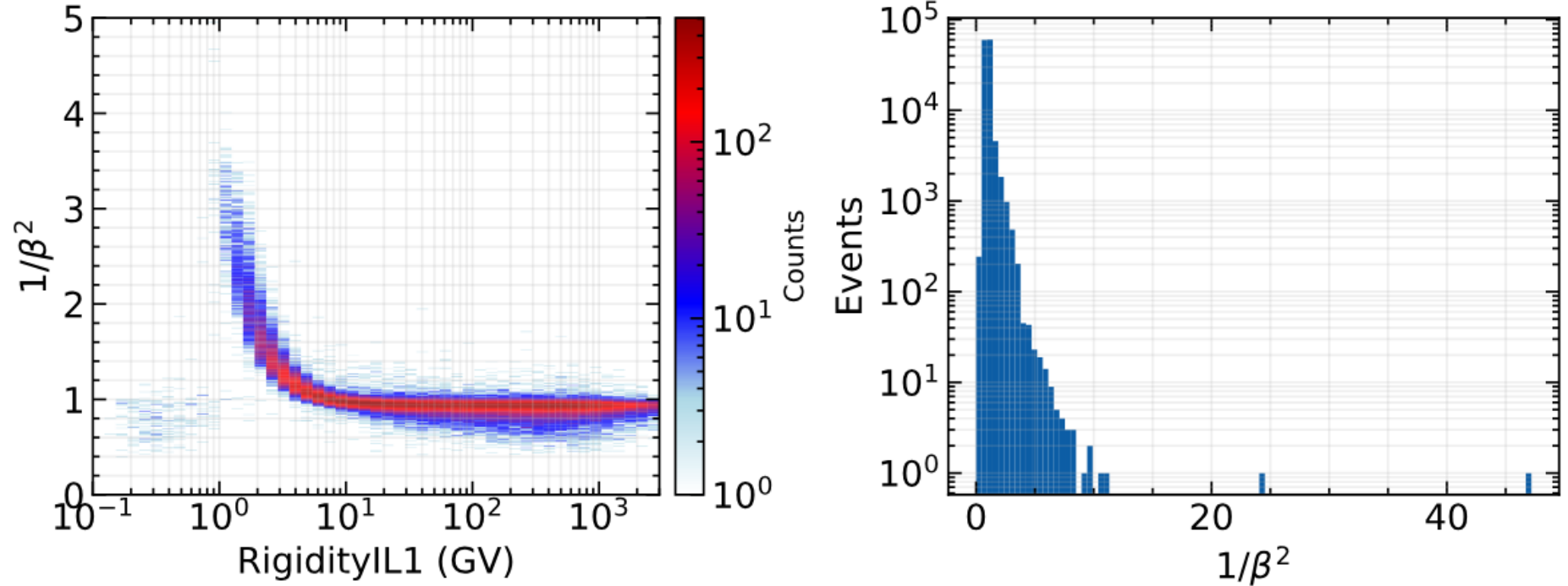


(Statistical error not added)  
(Similar plots for layer-6 in Backup slides)

# Unbiased TOF Beta (Sulfur MC, L1Inner selection, 200K events)

$\frac{1}{\beta^2}$ , standalone reconstruction:

(Clamp Beta values below 0.1 to 0.1)



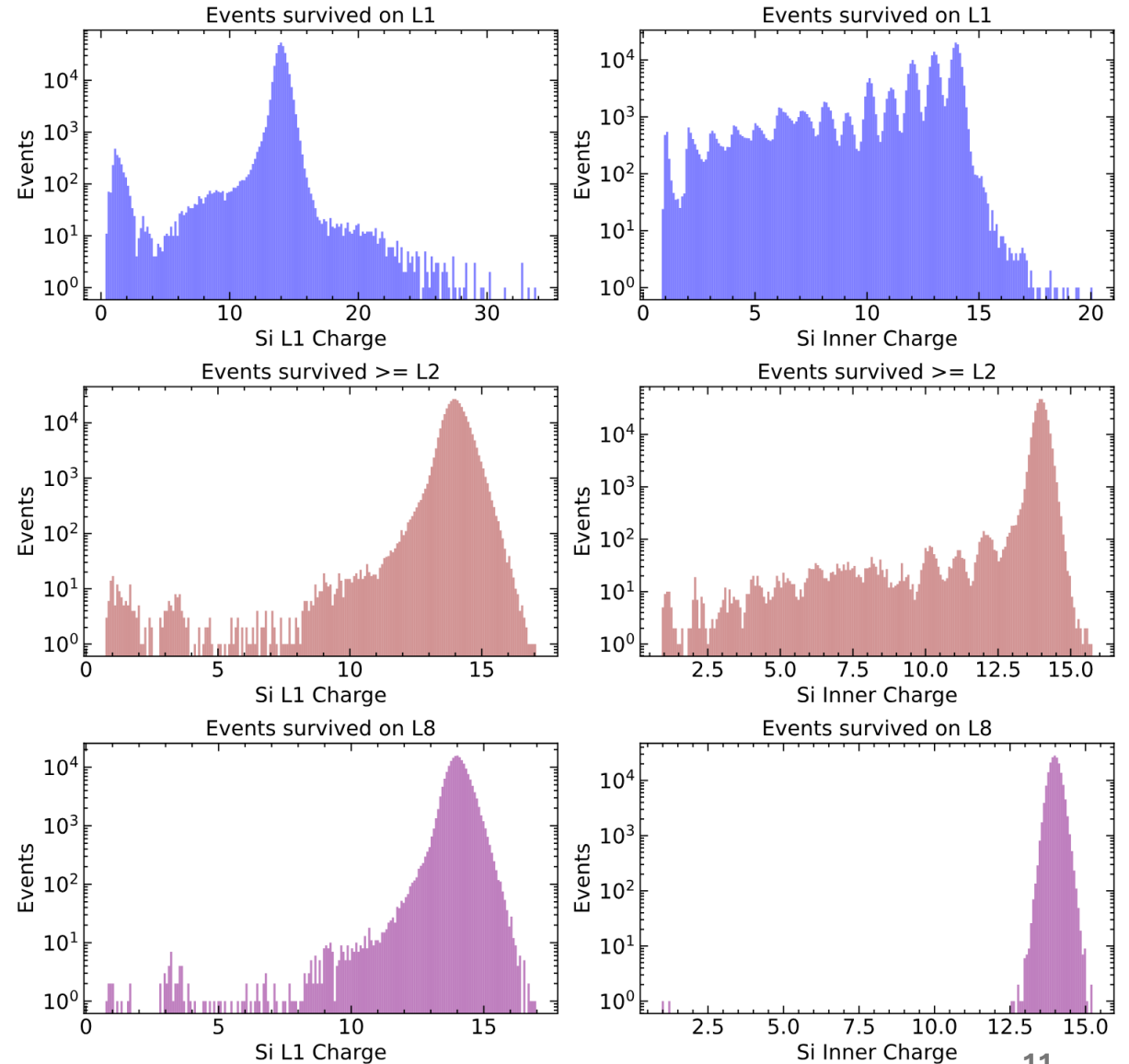
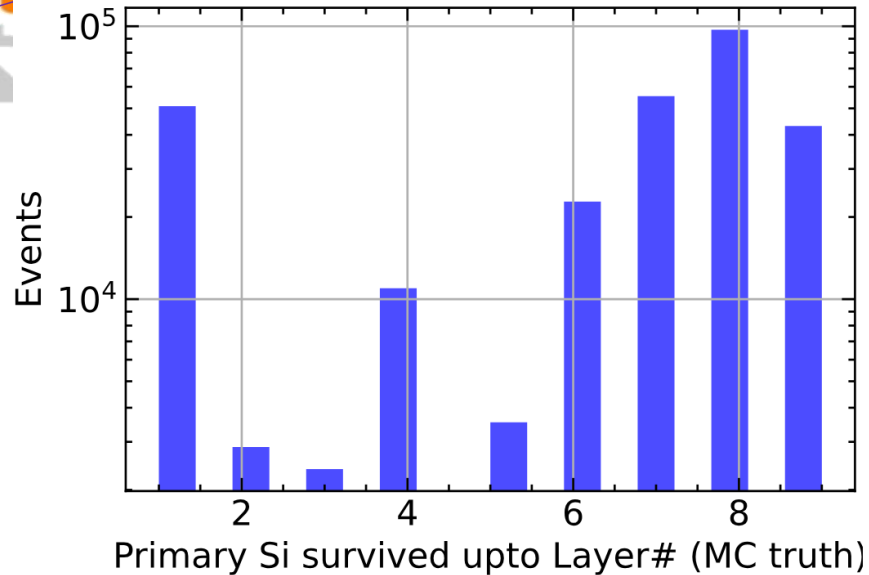
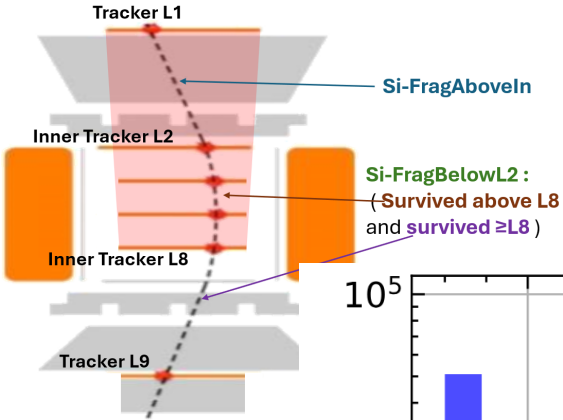
Besides Tracker hit cluster information,

→ Add the unbiased TOF Beta information ( $\frac{1}{\beta^2}$ ) to the deep learning model.

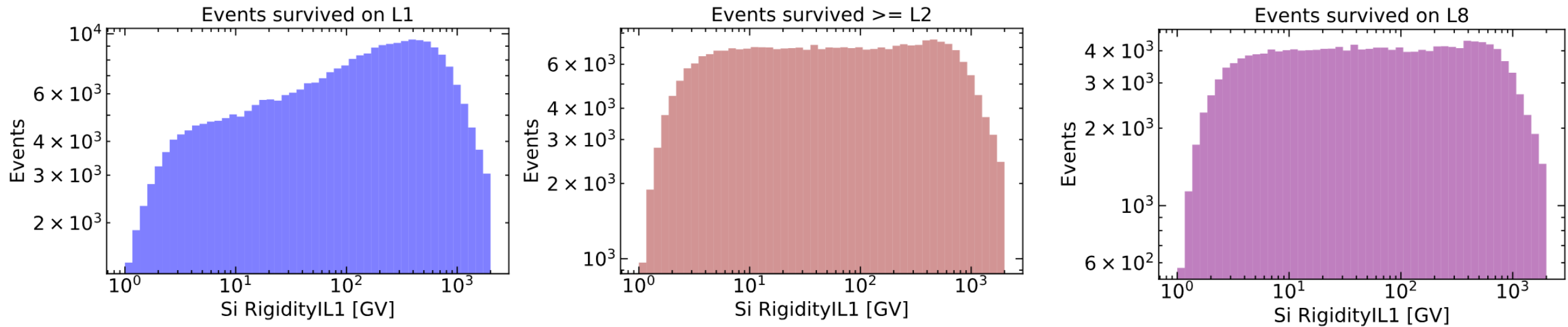
# Survived primary Si particles (MC truth)

MC truth information is used to discriminate:

- **Background 1:** primary Si survived above Inner.
- **Signal:** primary Si survived below L2 (**Survived in Inner** or **Survived on L8**)



# Survived primary Si particles (MC truth)

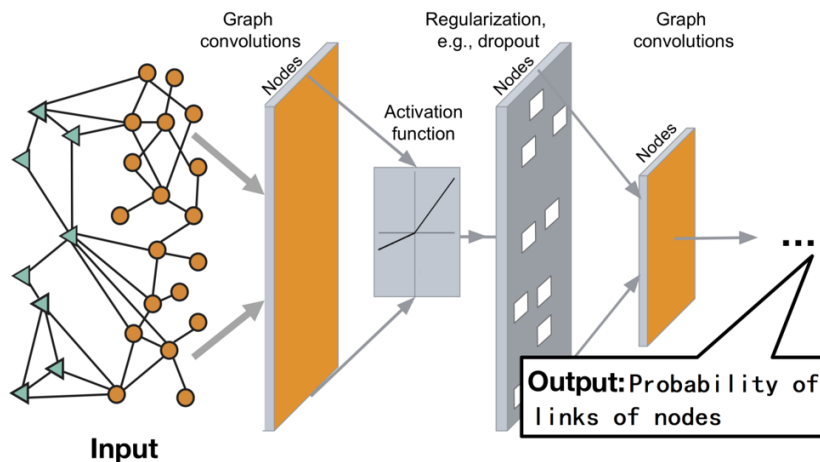


(For events fragmented above Inner, there are fewer events at low rigidity.)

## 2. GNN model

# Deep learning model: GNN

- GNN is one of the deep learning models suitable for AMS studies.
- It is possible to develop a multipurpose model based on GNN for different AMS tasks.



## GNN applications for AMS tracker:

- Edge/node classification → tracking;
  - global graph classification → nuclei, and isotope identification;
  - global graph regression → charge and rigidity reconstruction, etc.
  - graph pooling
- Start with a hybrid GNN model as an initial exploration.

Layer (type:depth-idx)	Param #
-----	-----
Sequential: 1-1	--
Linear: 2-1	640
LayerNorm: 2-2	256
GELU: 2-3	--
GCNConv: 1-2	--
SumAggregation: 2-4	--
Linear: 2-5	16,384
GCNConv: 1-3	--
SumAggregation: 2-6	--
Linear: 2-7	16,384
LayerNorm: 1-4	256
LayerNorm: 1-5	256
SAGEConv: 1-6	--
MeanAggregation: 2-8	--
Linear: 2-9	16,512
Linear: 2-10	16,384
SAGEConv: 1-7	--
MaxAggregation: 2-11	--
Linear: 2-12	16,512
Linear: 2-13	16,384
LayerNorm: 1-8	512
GATConv: 1-9	--
SumAggregation: 2-14	--
Linear: 2-15	32,768
LayerNorm: 1-10	256
Sequential: 1-11	--
Linear: 2-16	33,024
LayerNorm: 2-17	256
GELU: 2-18	--
Dropout: 2-19	--
ModuleList: 1-12	--
Linear: 2-20	8,256
LayerNorm: 2-21	128
GELU: 2-22	--
Dropout: 2-23	--
Linear: 2-24	2,080
LayerNorm: 2-25	64
GELU: 2-26	--
Dropout: 2-27	--
Linear: 2-28	99
-----	-----
Total params: 177,411	
Trainable params: 177,411	
Non-trainable params: 0	
-----	-----

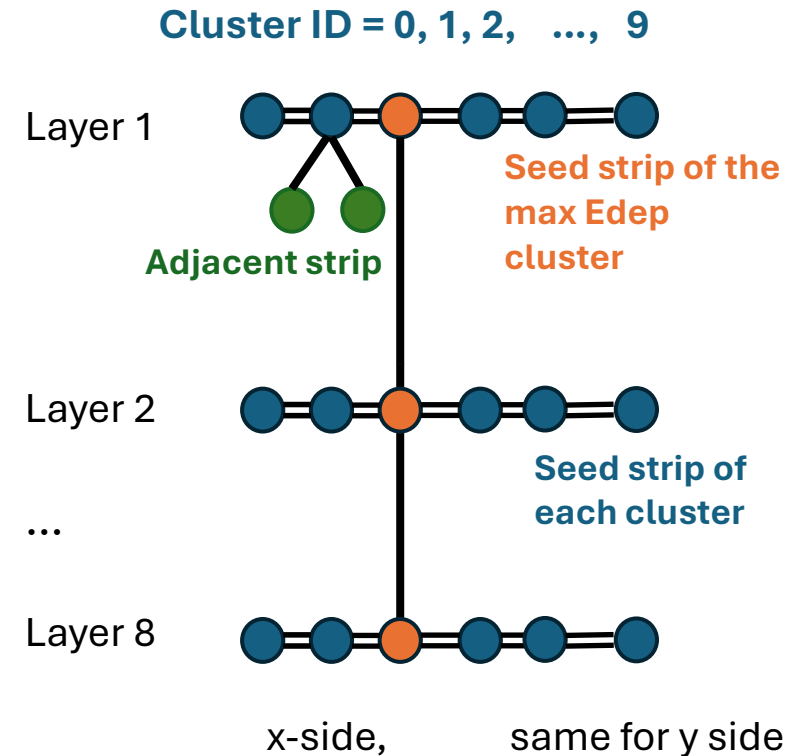
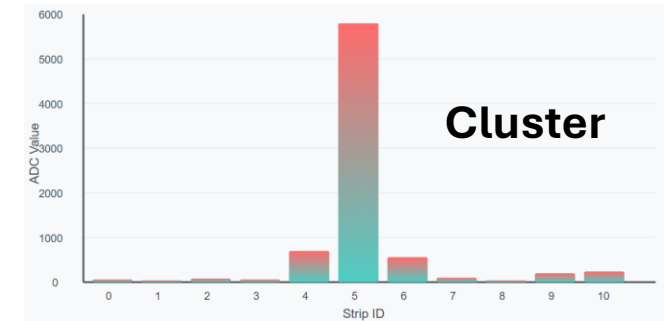
Model architecture used in this work

# Graph construction for GNN input

- **Graph nodes:** 10 seed strips and 3 adjacent strips(left and right) for each layer and side.
- **Graph Node features:** ADC value, strip id, side, layer;
- **Graph Edge connection:**
  1. connect the seed strip of the max Edep cluster to other seed strips within the same layer and side, (bidirectional connections);
  2. connect each seed strip to its adjacent strips;
  3. connects the seed strips of the largest clusters between the X- and Y- sides within the same layer, (bidirectional connections) connect the seed strips of the max Edep clusters in adjacent layers for the same side.
- **Event level features: Unbiased TOF Beta ( $1/\beta^2$ )**

Number of nodes and edges (including strips with ADC=0):

- 366 edges
- 256 nodes
- 4 node features
- 1 event level feature



# 3. Results

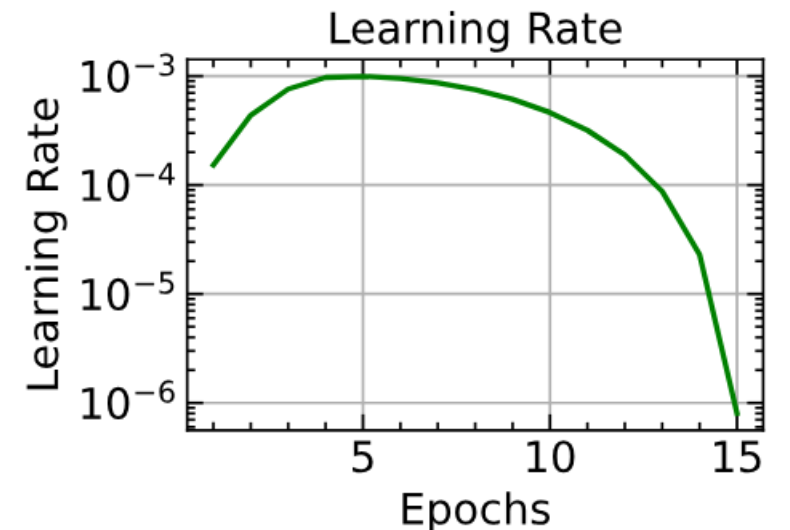
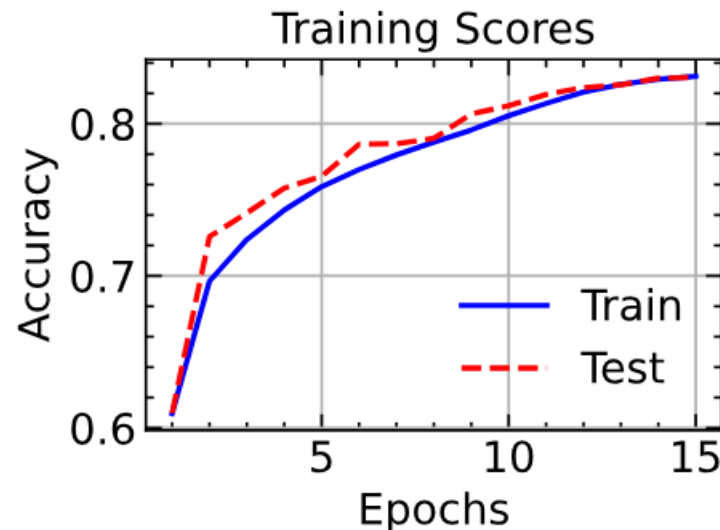
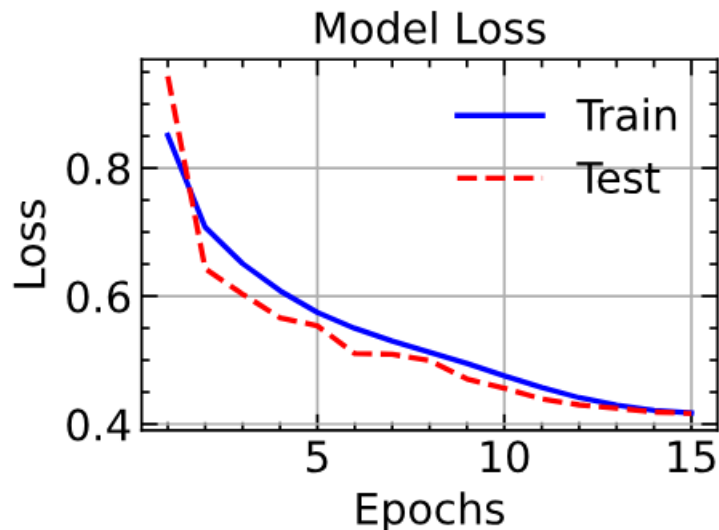


# GNN model training result

Task: 3-label classification (input sample: 3 category, 300k events each)

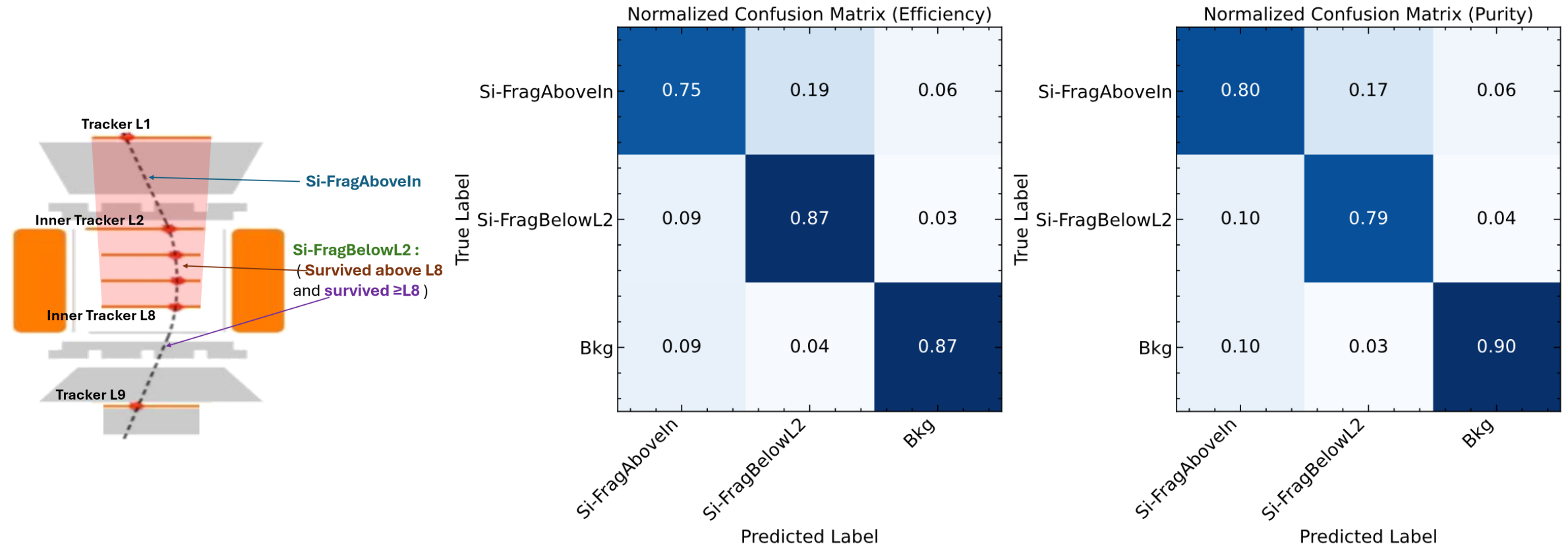
1. Si fragmented above Inner
2. Si fragmented below L2
3. Background nuclei (Mg, Al, P, S = 0.1 : 1 : 1 : 0.1)

Model training and validation performance:



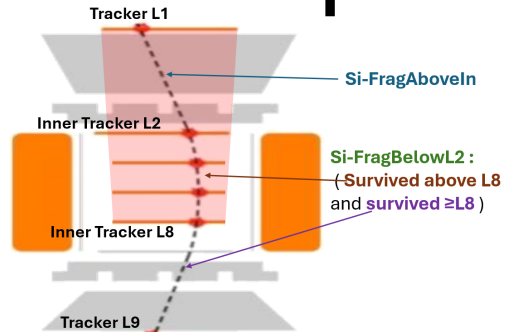
# Model overall performance: model validation result

Based on validation sample for each nuclei (~200k events in total):

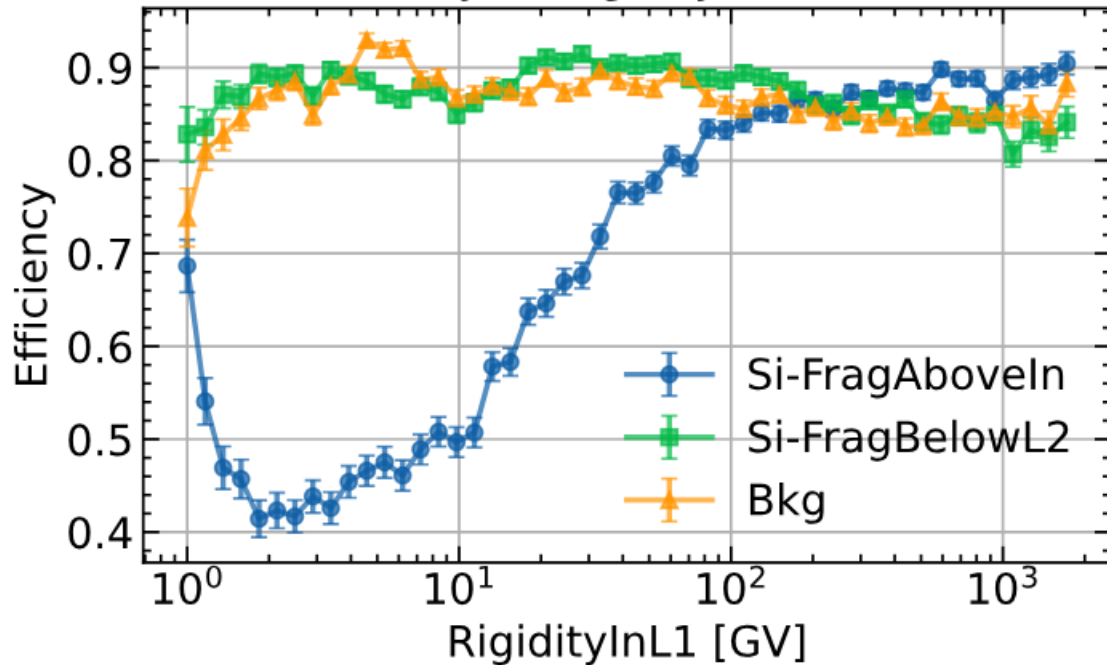


- Given a true label, Efficiency is the probability of each prediction;
- Given a prediction, Purity is the probability of each true label.

# Model performance: model validation result



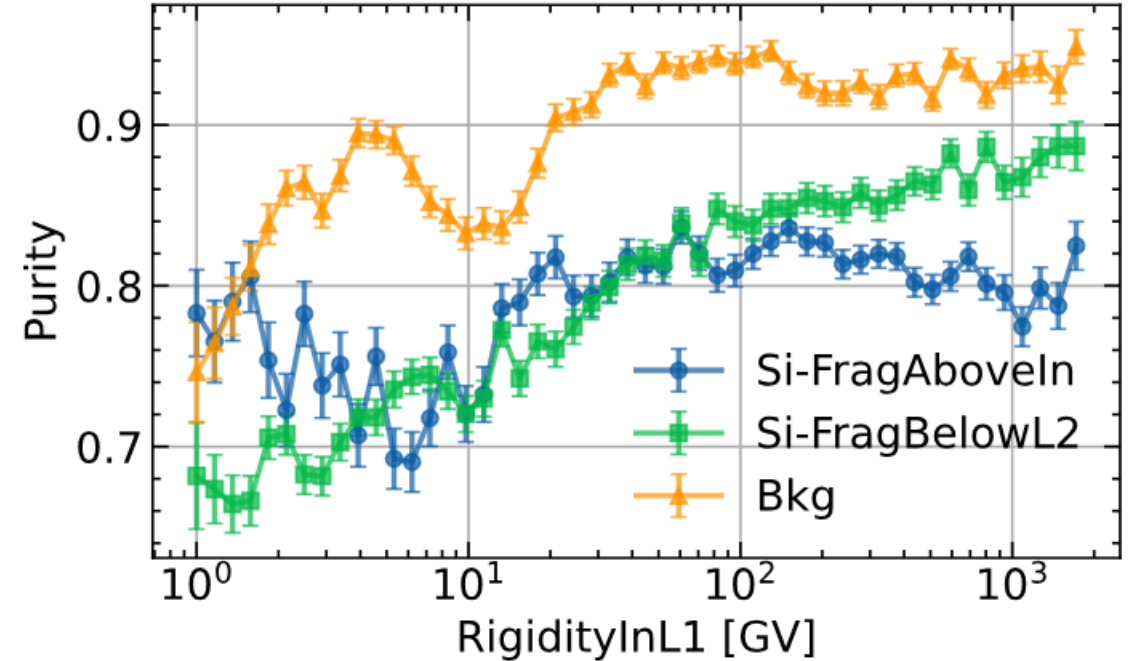
Efficiency vs Rigidity (All events)



Purity calculated based on events ratio:

- Si-FragAboveIn : Si-FragBelowL2 : Bkg = 1 : 1 : 1
- Bkg: Mg, Al, P, S = 0.1 : 1 : 1 : 0.1

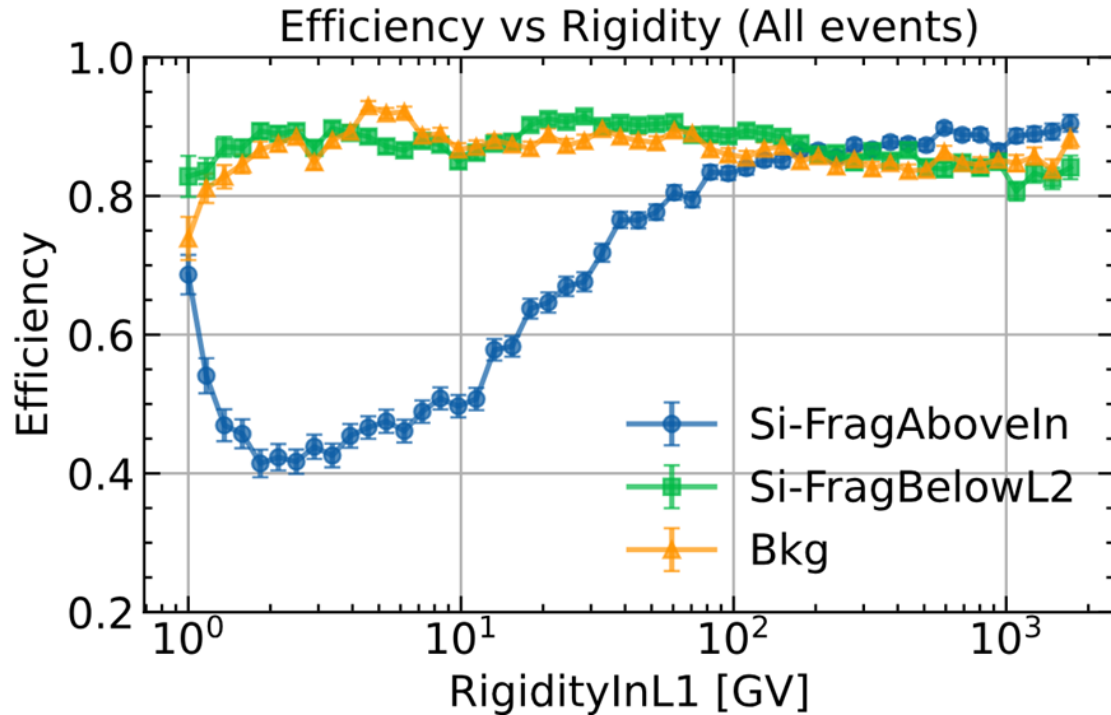
Purity vs Rigidity (All events)



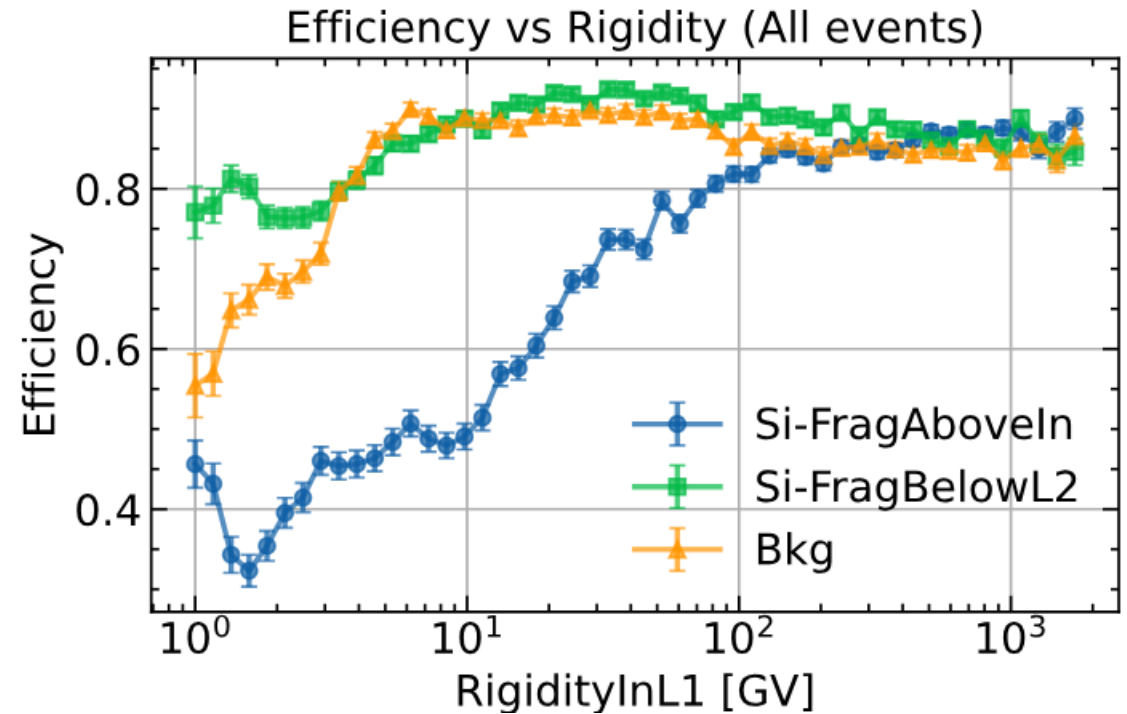
In the sample, for **events fragmented above Inner**, there are fewer events at low rigidity (slide#12),  
→ larger statistical error for **Si-FragAboveIn** at low rigidity.

# Model performance: model validation result

**With** TOF Beta information (this result)

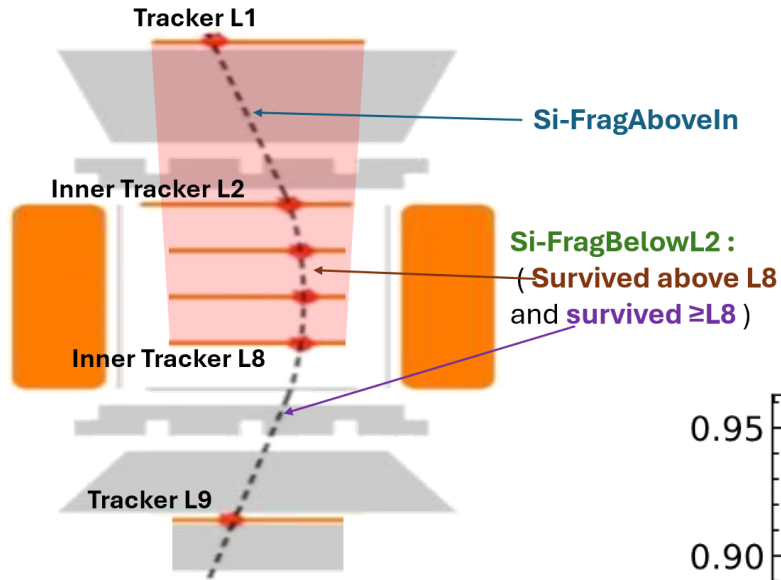


**Without** TOF Beta information

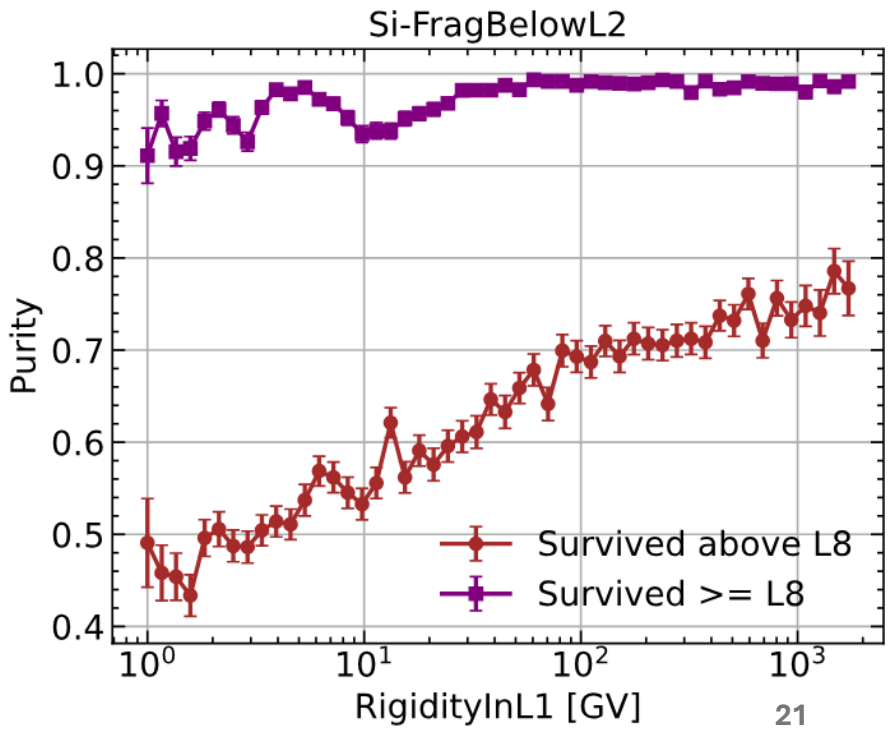
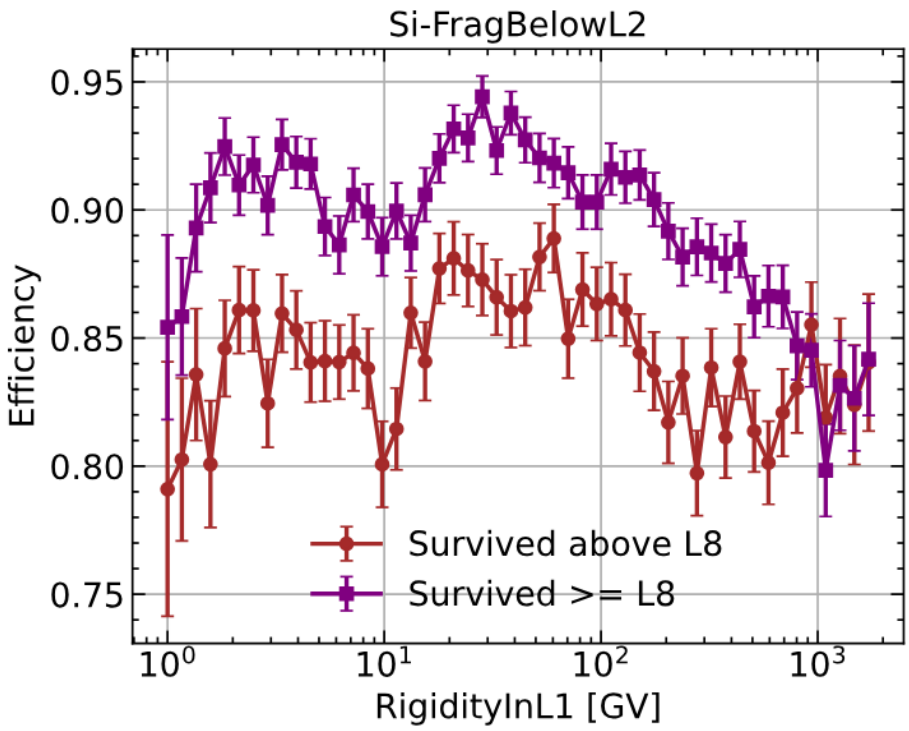


Adding TOF information:  
overall performance improves, and the rigidity dependence at low rigidity is reduced.

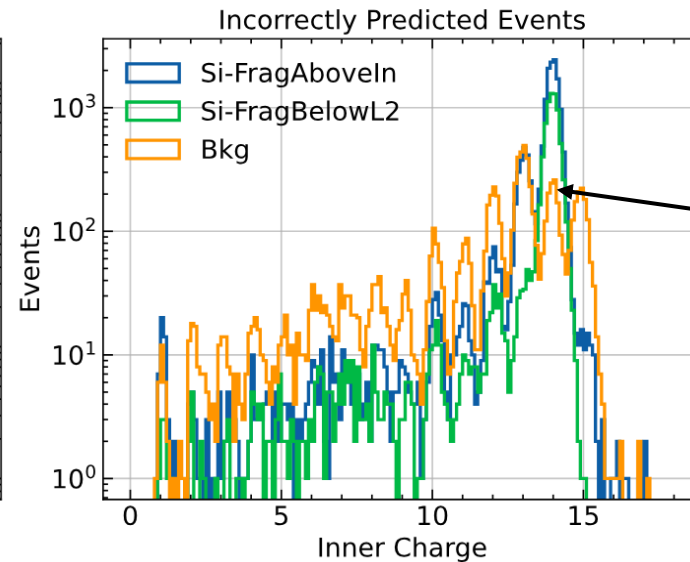
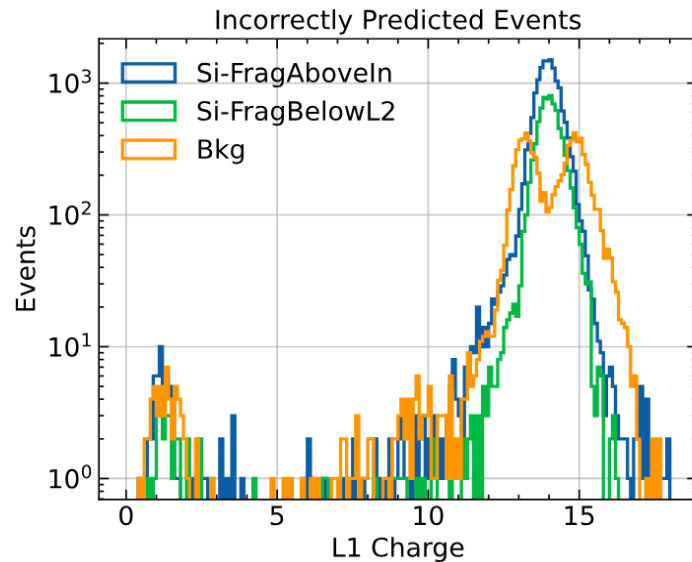
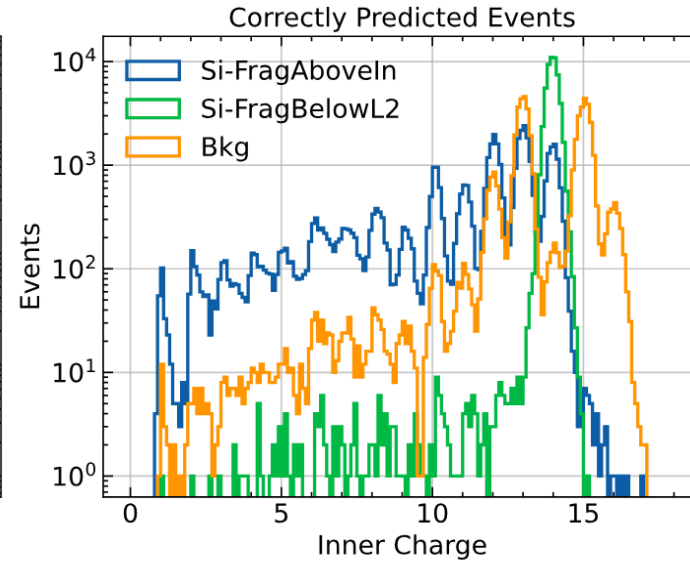
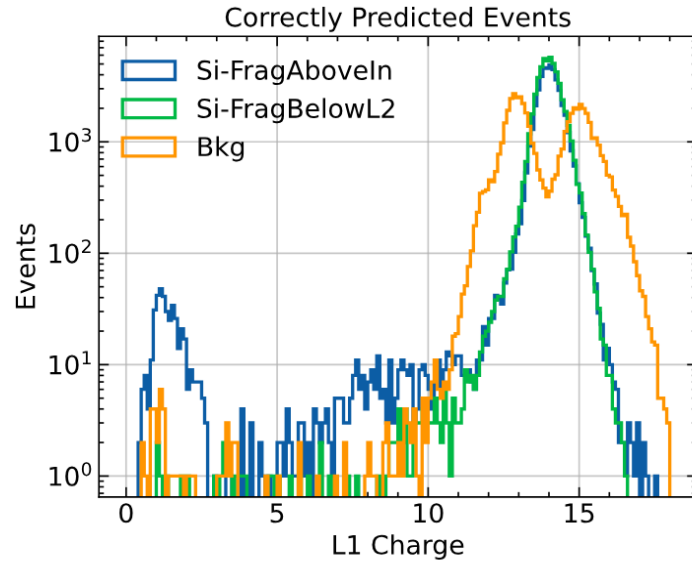
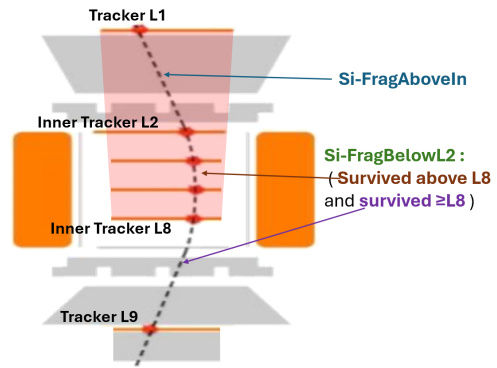
# Model performance: model validation result for Si fragmented below L2



Model testing result for **Interacting Si events in Inner Tracker** and **Non-Interacting Si events** :

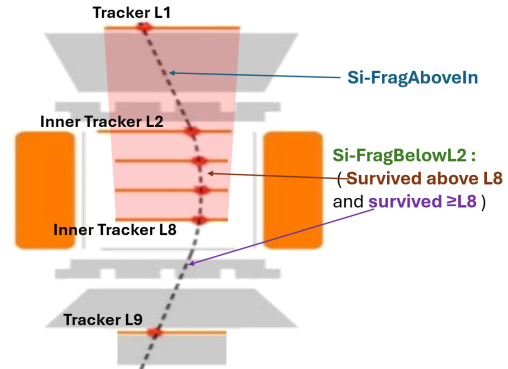


# Model performance: comparison to standard charge reconstruction results

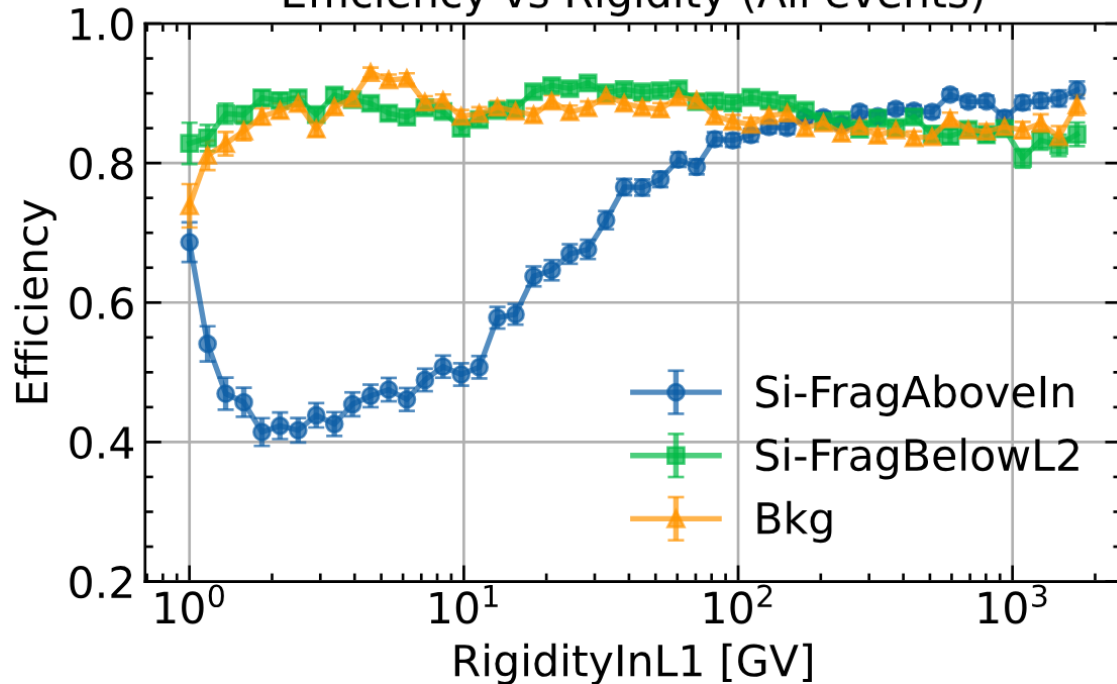


(  
Low rigidity events:  
• Small charge  
• Large ADC  
• Small number of  
clusters  
)

# Model performance: comparison to standard selection efficiency



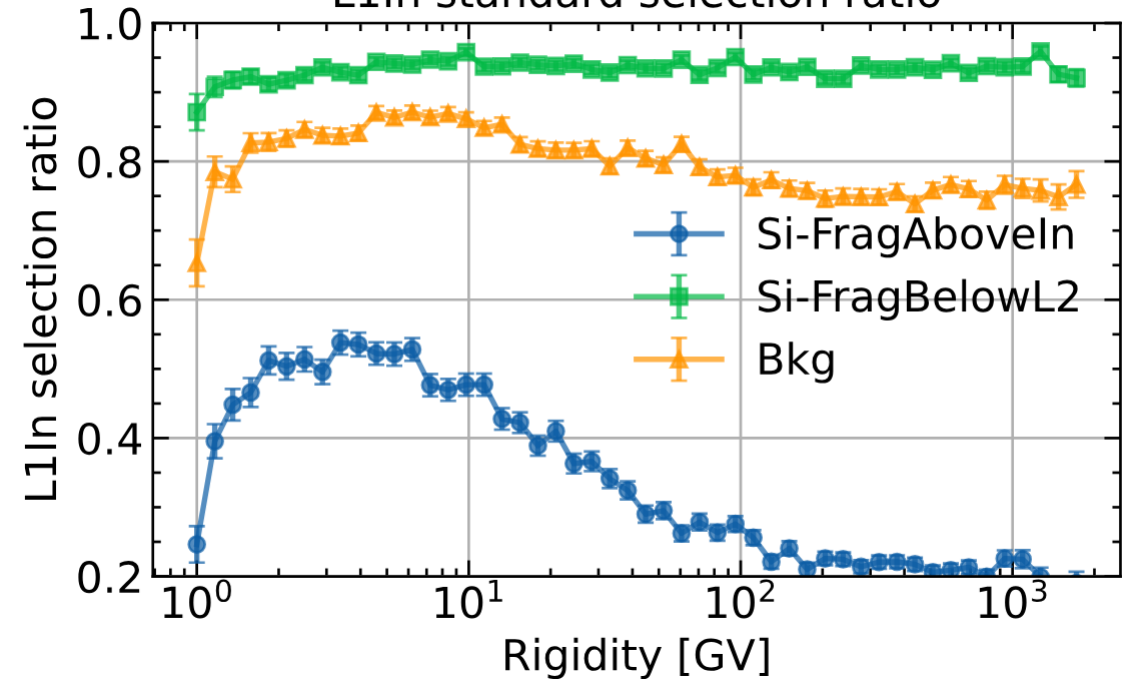
Efficiency vs Rigidity (All events)



## Standard selection results for reference:

(Standard Si selection for Si-FragAboveIn and Si-FragBelowL2)  
(Standard Mg, Al, P, S selections for Mg, Al, P, S)

L1In standard selection ratio

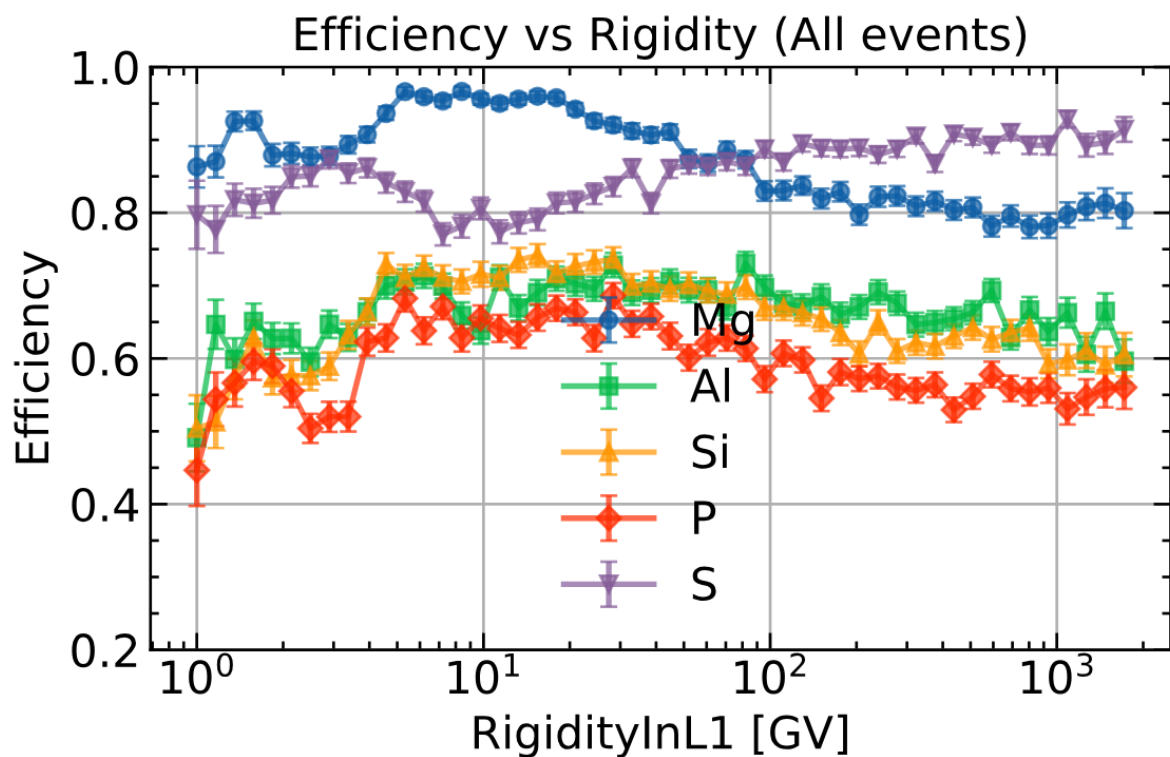


# Extending the model for other tasks:

Based on the method, the model can be extended for other tasks:

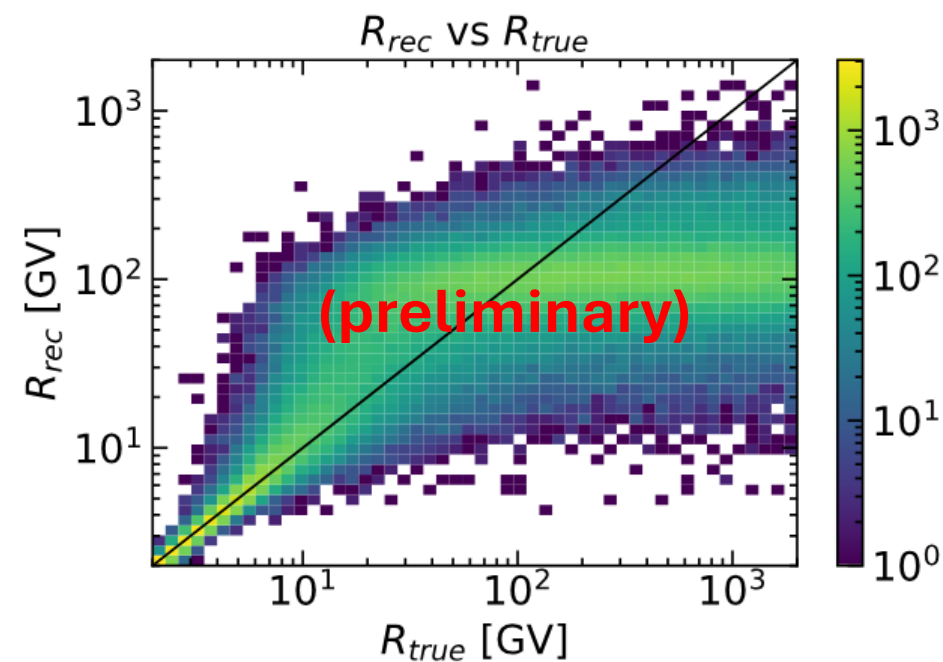
**On-going:**

nuclei identification for Mg, Al, Si, P, S



**On-going:**

true rigidity reconstruction





# Summary and To-do

**A preliminary study using MC for nuclei identification with deep learning method shows promising potential compared to traditional method.**

## **To-do:**

- **Lots of optimizations needed:**

1. Optimizing graph construction method (variable number of nodes/edge, group by distance, find Edep threshold value, etc.)
2. Implementing stat-of-the-art models
3. Model hyperparameter optimization
4. Further improve Low rigidity performance with Rigidity Piecewise training

- **Implementing MC reweight method for Data–MC consistency**

Backup

# ADC correction options in AMS software

◆ CorrectionOptions

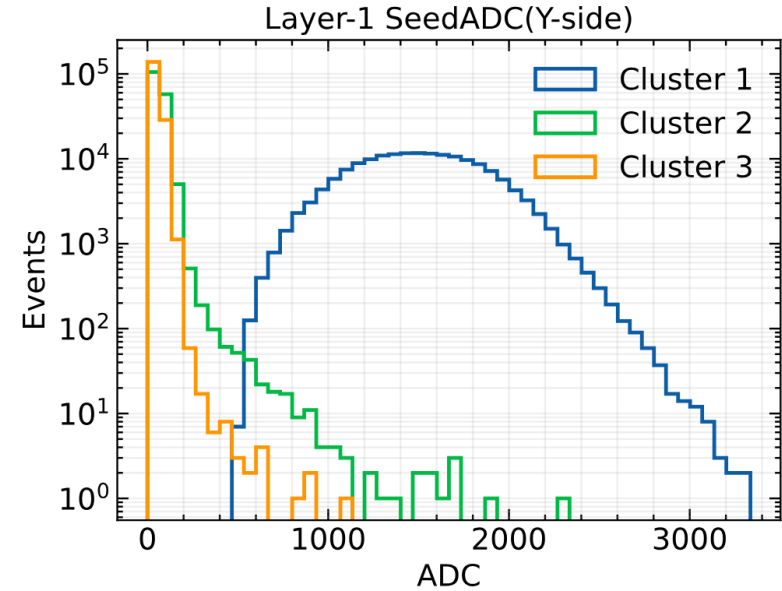
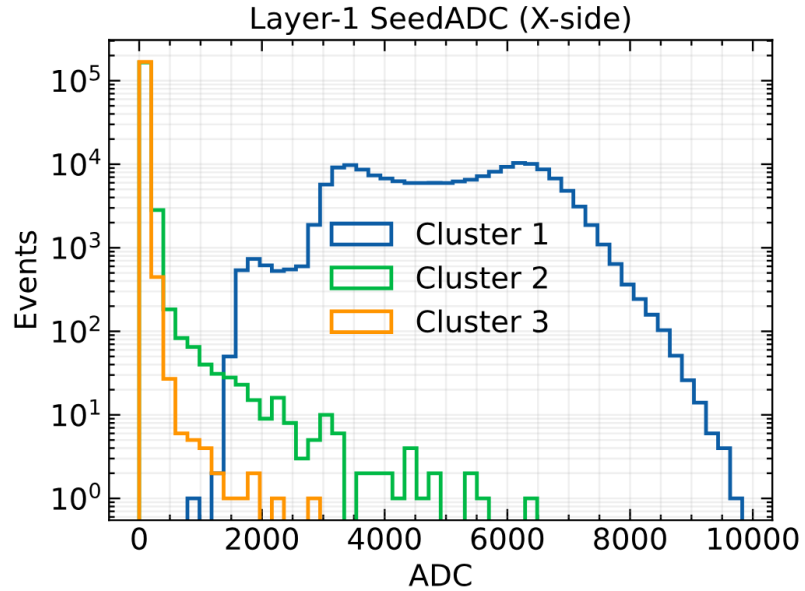
enum **TrClusterR::CorrectionOptions**

Enumerator	
kNoCorr	No Correction Applied.
kAsym	Signal Corr.: Cluster Asymmetry Correction (left/right)
kPStrip	Signal Corr.: P-Strip Correction.
kAngle	Total Signal Corr.: Energy Loss Normalization at 300 um $[\cos(\Theta)^{-1}]$ .
kGain	Total Signal Corr.: Gain Correction.
kLoss	Total Signal Corr.: Charge Loss Correction.
kLoss2	Total Signal Corr.: Charge Loss Correction (alternative to kLoss)
kPN	Total Signal Corr.: Normalization to P-Side (probably not working, however not really needed)
kMIP	Total Signal Corr.: Normalization to number of MIP.
kMeV	Total Signal Corr.: Multiply by 300 um MIP energy deposition (estimated to be 81 keV)
kBeta	Total Signal Corr.: Beta correction.
kRigidity	Total Signal Corr.: Rigidity correction.
kCoupl	Coordinate Corr.: Correct for the charge coupling (4%)
kBelau	Coordinate Corr.: Belau correction.
kOld	Use old charge calibration.
kAsymEta	Signal Corr.: New Cluster Asymmetry Correction (left/right)
kQ2Eta	ADC->Q2 Correction: ADC to Q2(Z gain)
kTotSign2017	Charge calibration 2017 (for now used only for MC)
kSimAsym	Signal Corr.: Cluster asymmetry correction using TRMCFFKEY.Asymmetry.
kSimSignal	Total Signal Corr.: raw ADC to MIP scale for every VA.
kOverflow	ADC Overflow Corr.

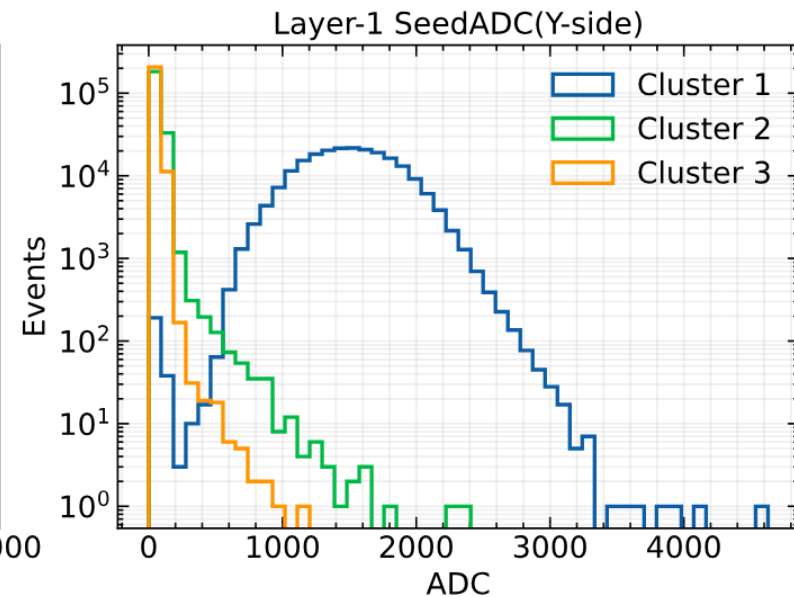
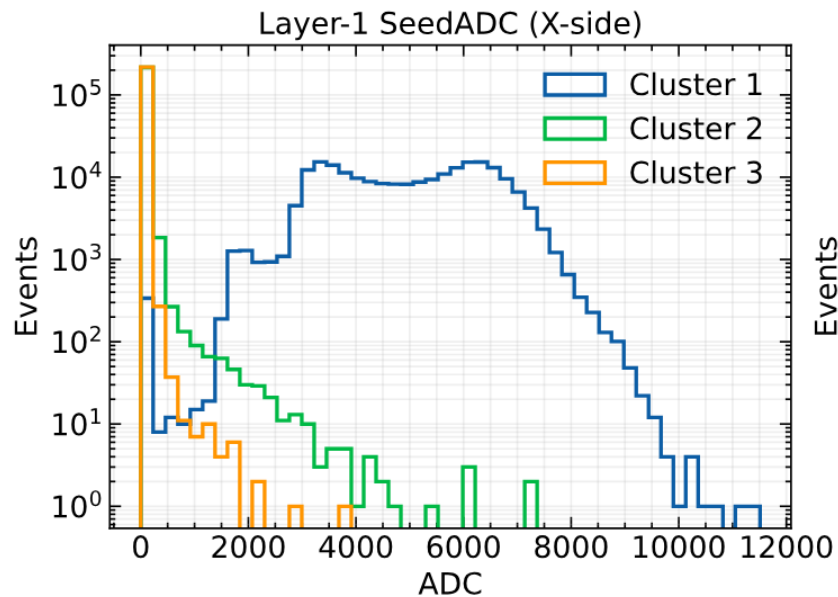
Definition at line 54 of file **TrCluster.h**.

# ADC Values (Sulfur MC, L1Inner selection, 200K events)

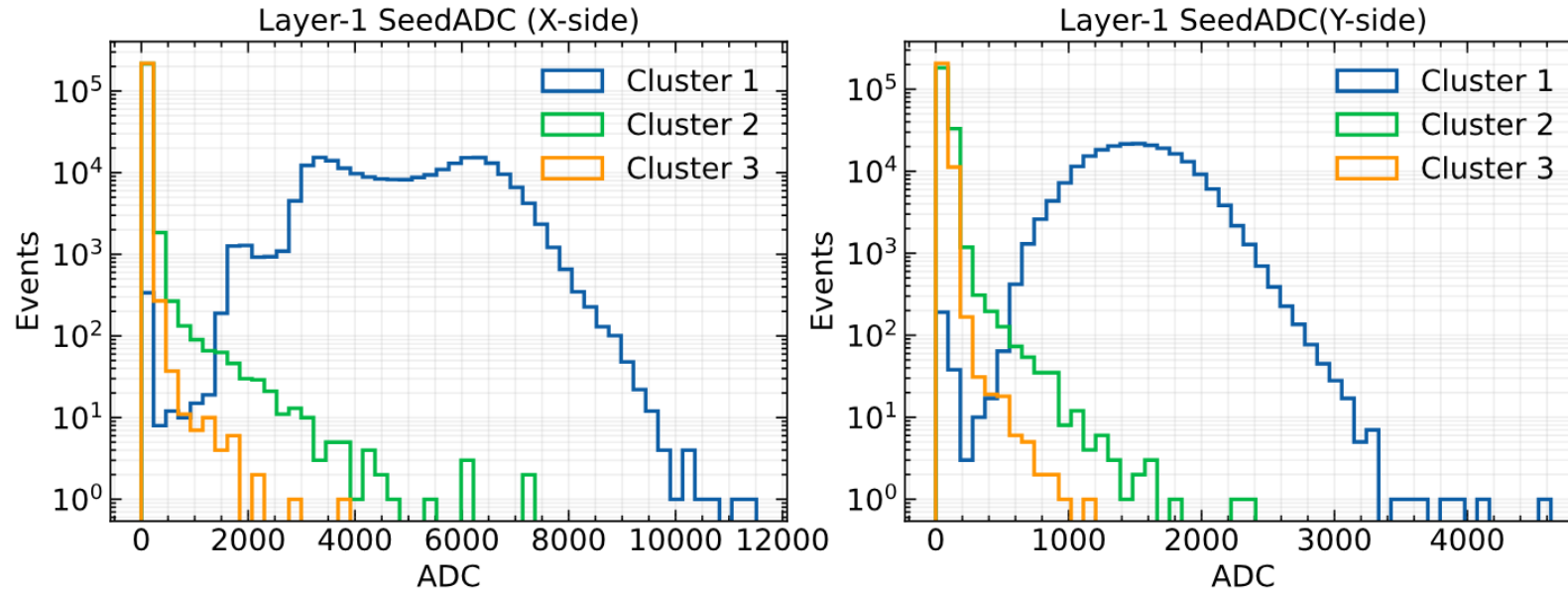
ADC without correction



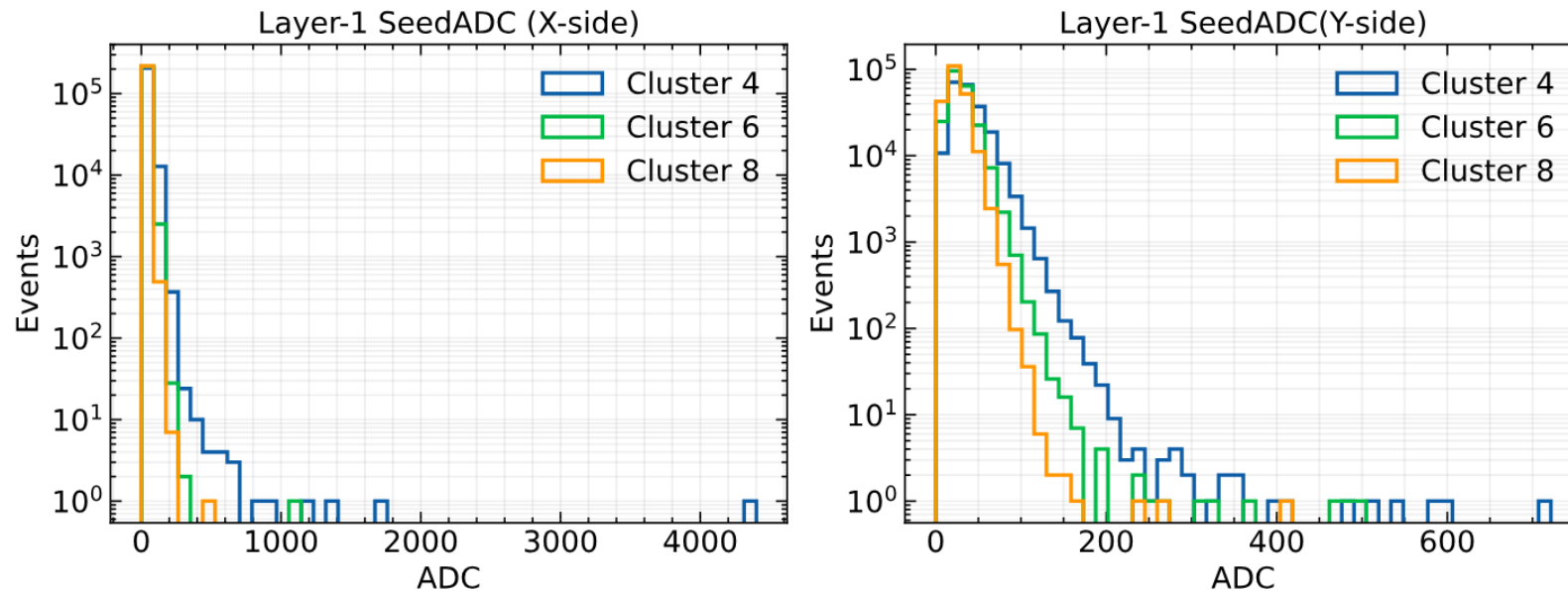
ADC with Beta correction (kBeta)



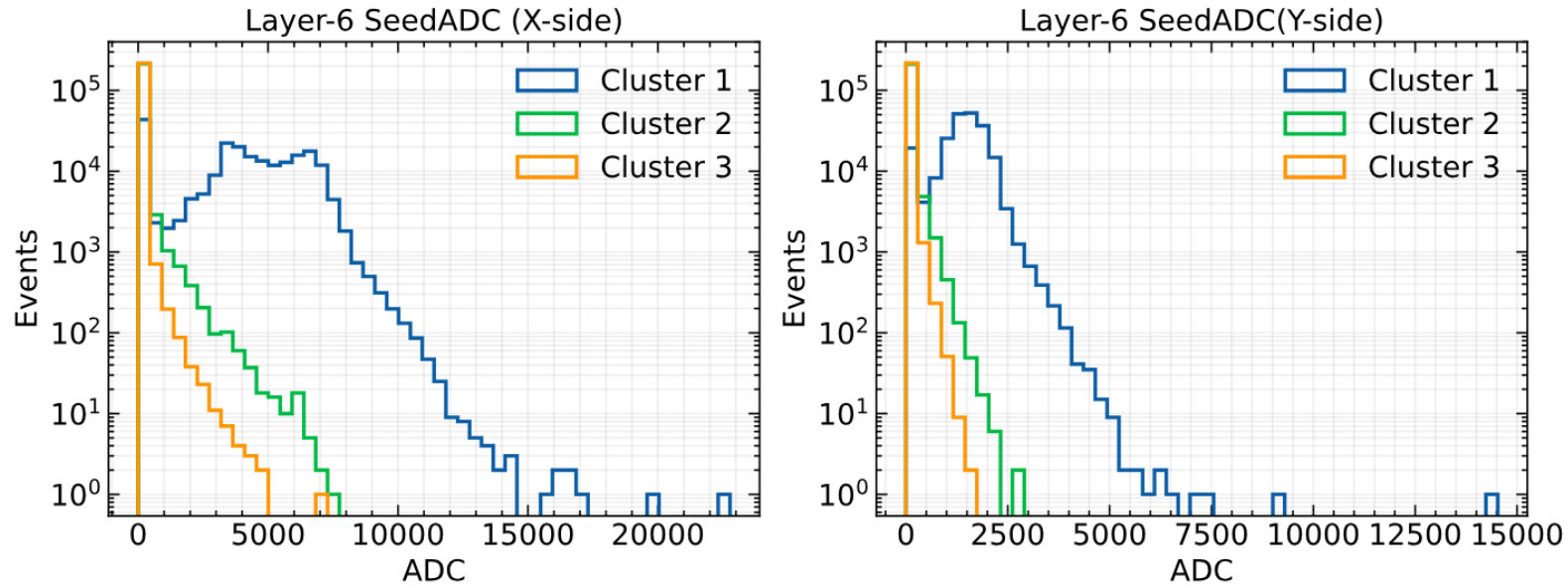
# ADC Values (S MC L1Inner selection, 200K events)



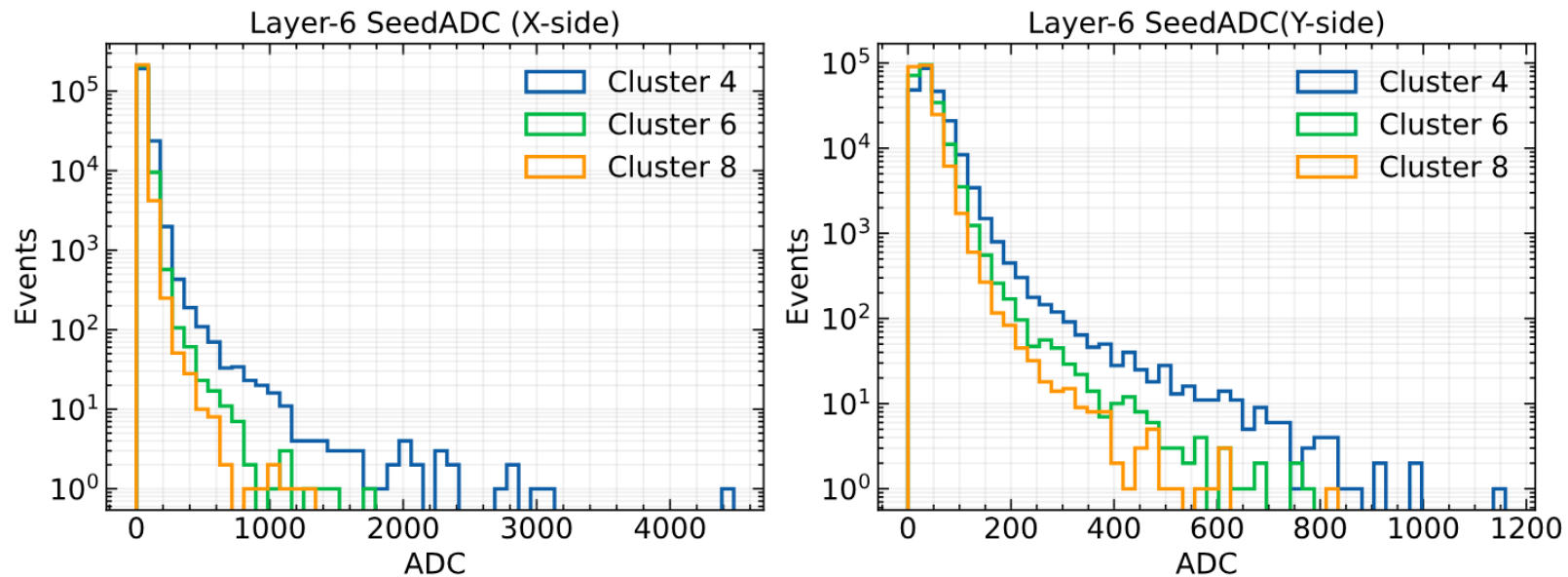
SeedADC Distributions for Layer-0



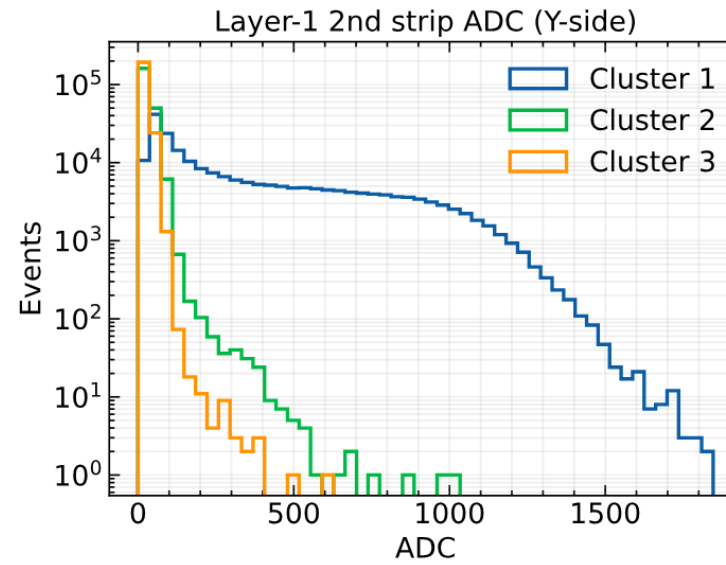
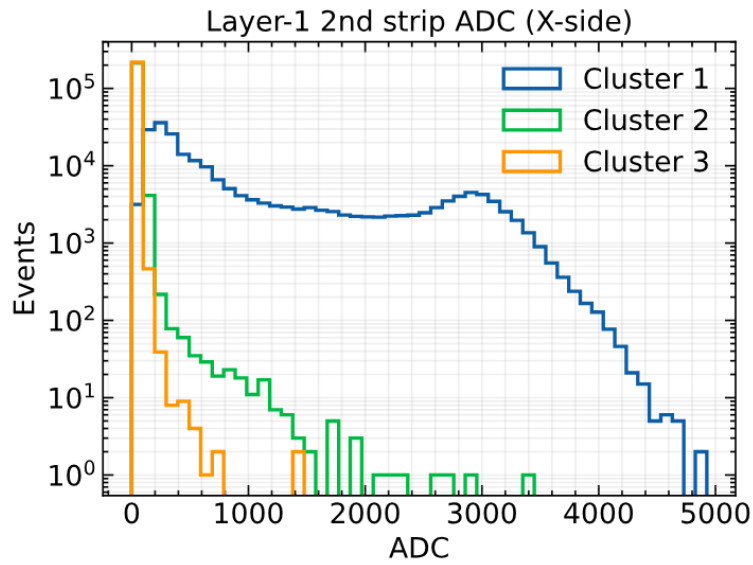
# ADC Values (S MC L1Inner selection, 200K events)



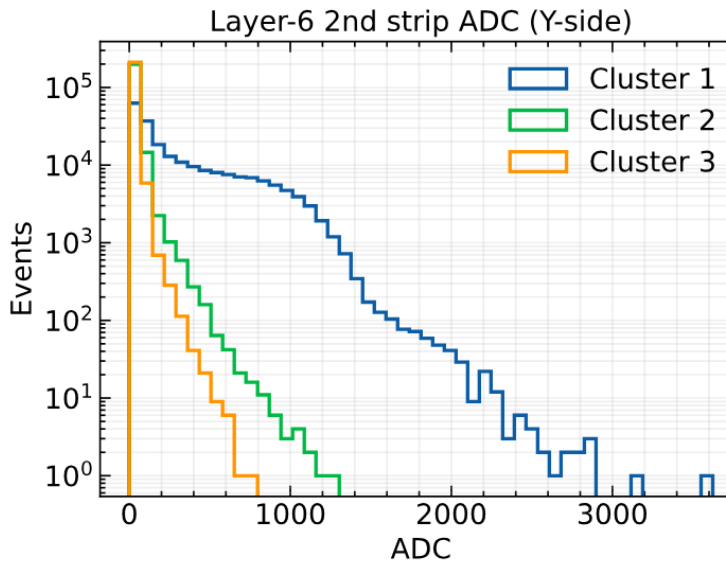
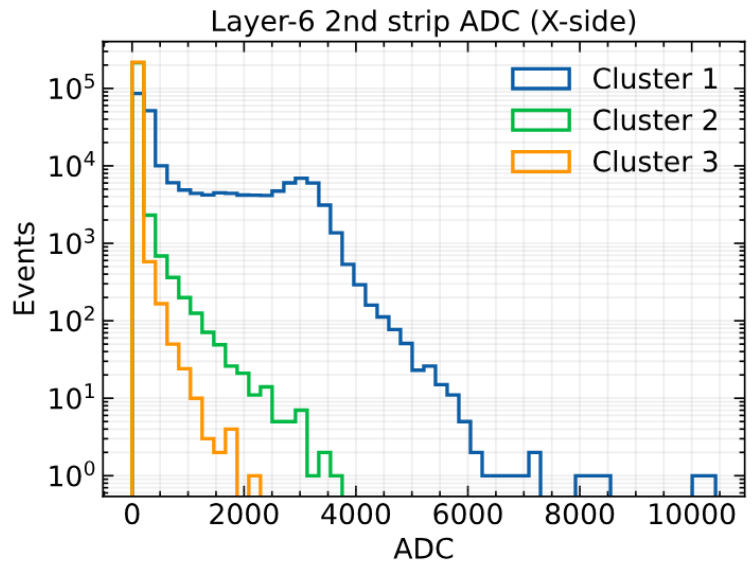
SeedADC Distributions for Layer-5



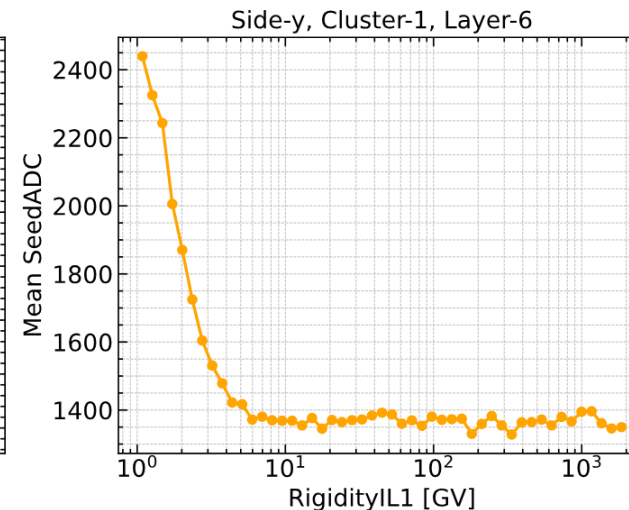
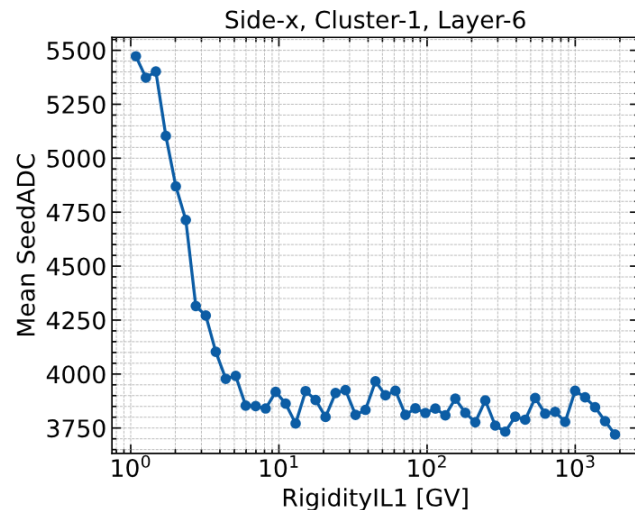
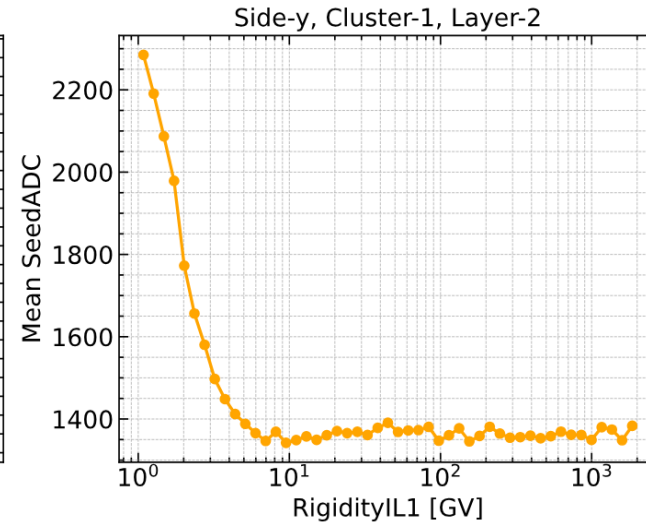
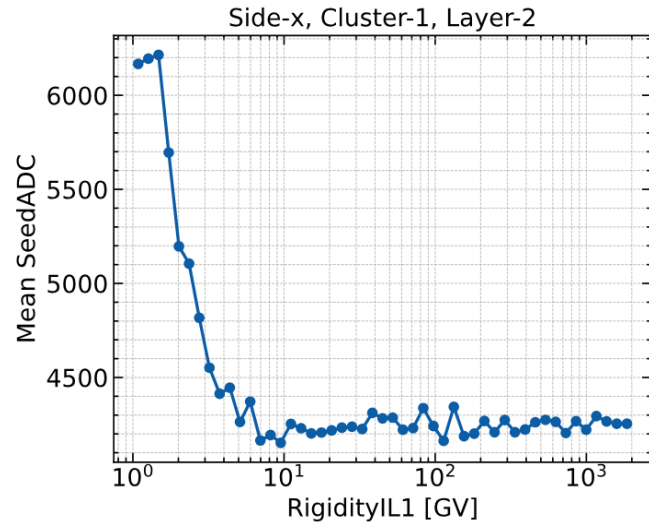
# ADC Values (S MC L1Inner selection, 200K events)



SeedADC Distributions for Layer-5



# Rigidity dependence of ADC with Beta correction (Sulfur MC, L1Inner selection, 200K events)

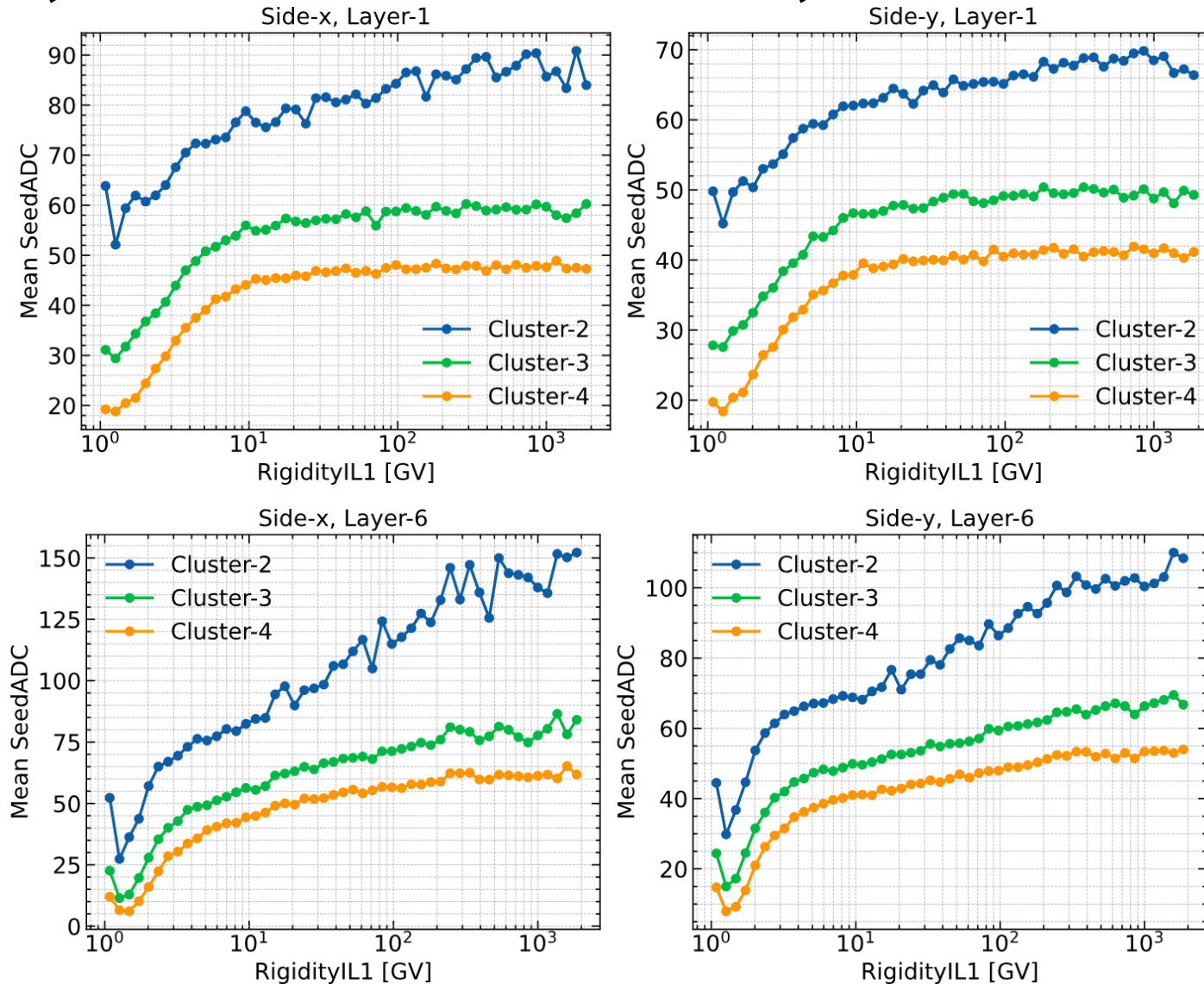


**Further Beta correction is needed.**  
**→ Add TOF Beta information to the deep learning models**

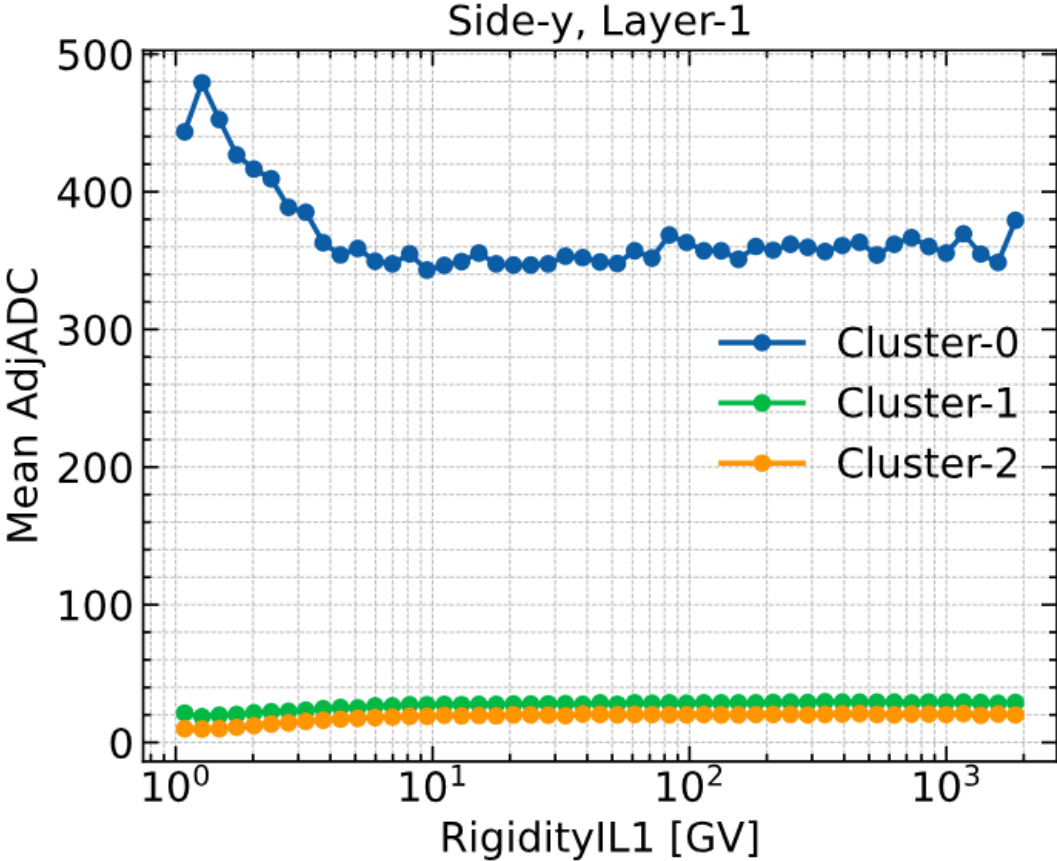
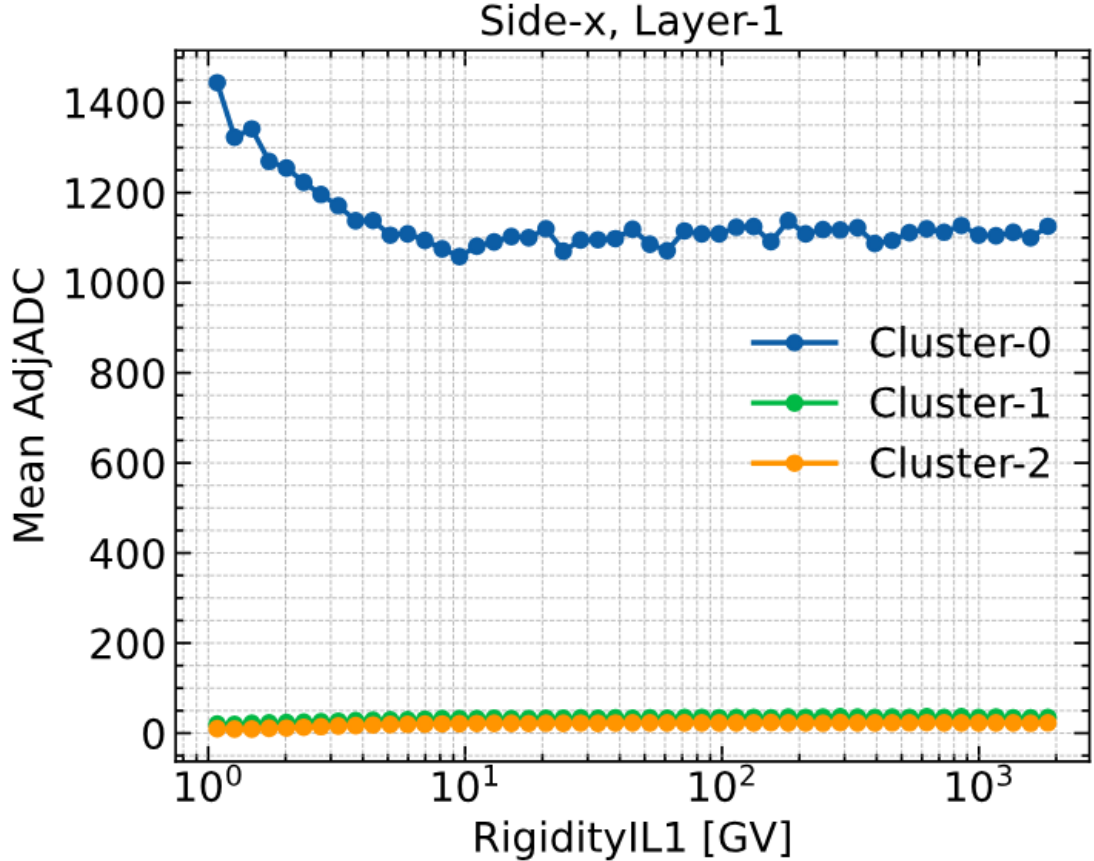
(Statistical error not added)



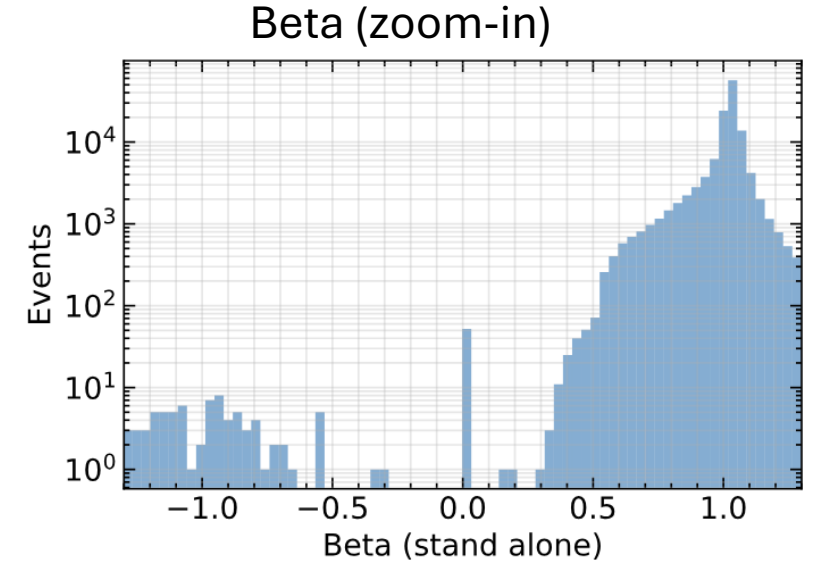
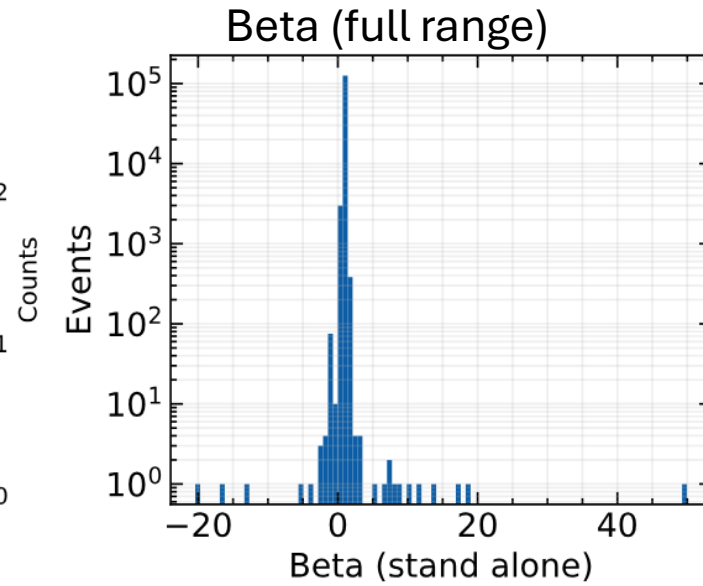
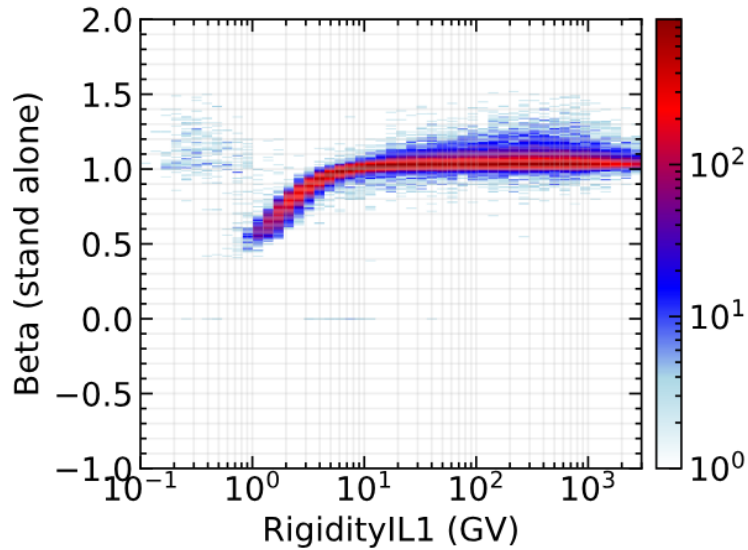
# Rigidity dependence of ADC with Beta correction (Sulfur MC, L1Inner selection, 200K events)



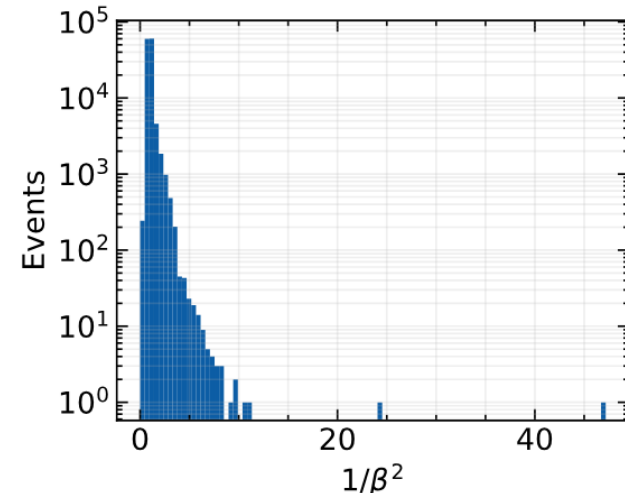
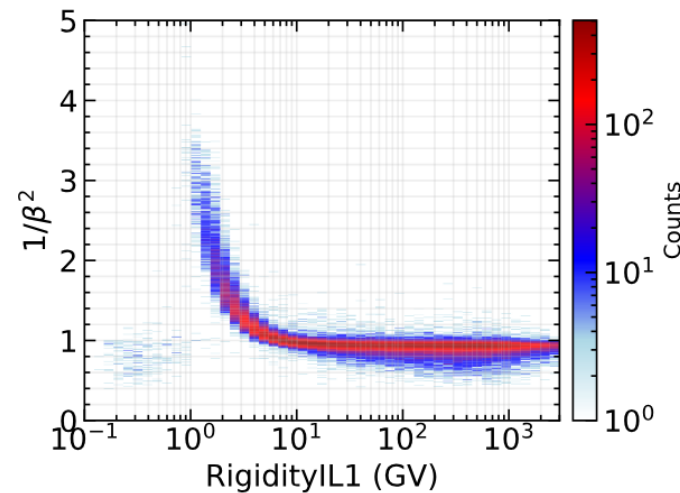
# Rigidity dependence (ADC with kBeta)



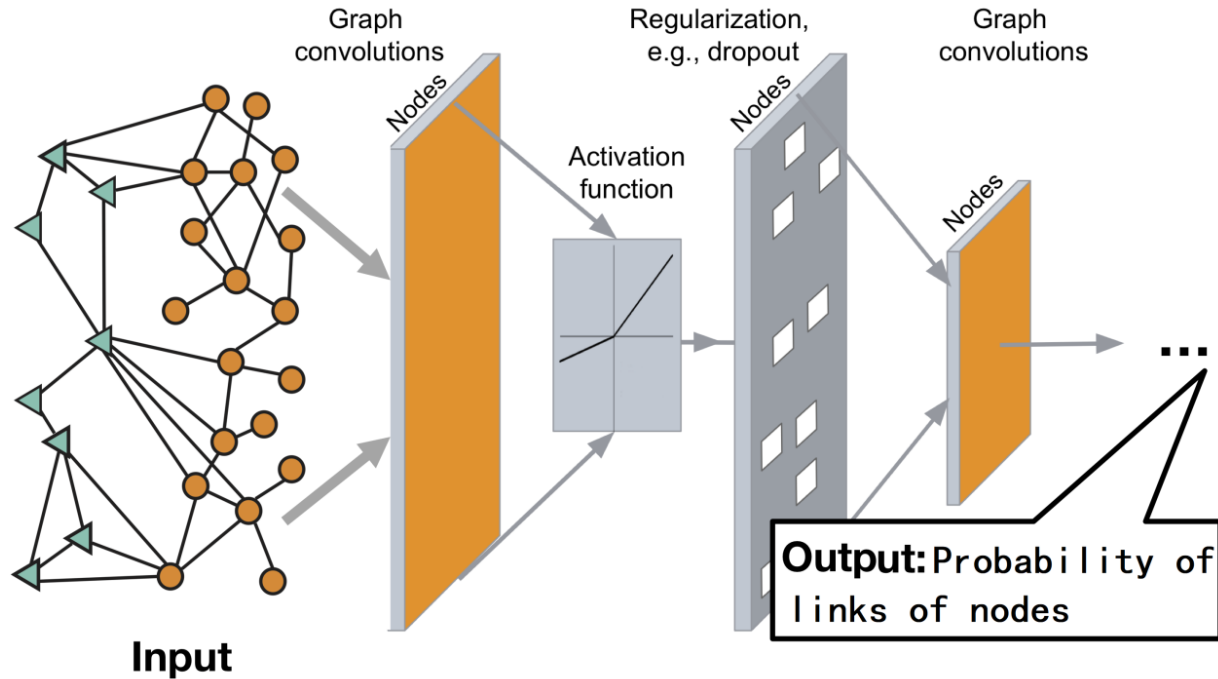
# TOF Beta (standalone reconstruction)



Clamp Beta values below 0.1 to 0.1:



# Deep learning models: GNN



## GNN applications for AMS tracker:

- Edge/node classification → tracking;
- global graph classification → nuclei, and isotope identification;
- global graph regression → charge and rigidity reconstruction, etc.
- ~~graph pooling~~

Pros: suitable for sparse signal; suitable track finding tasks.

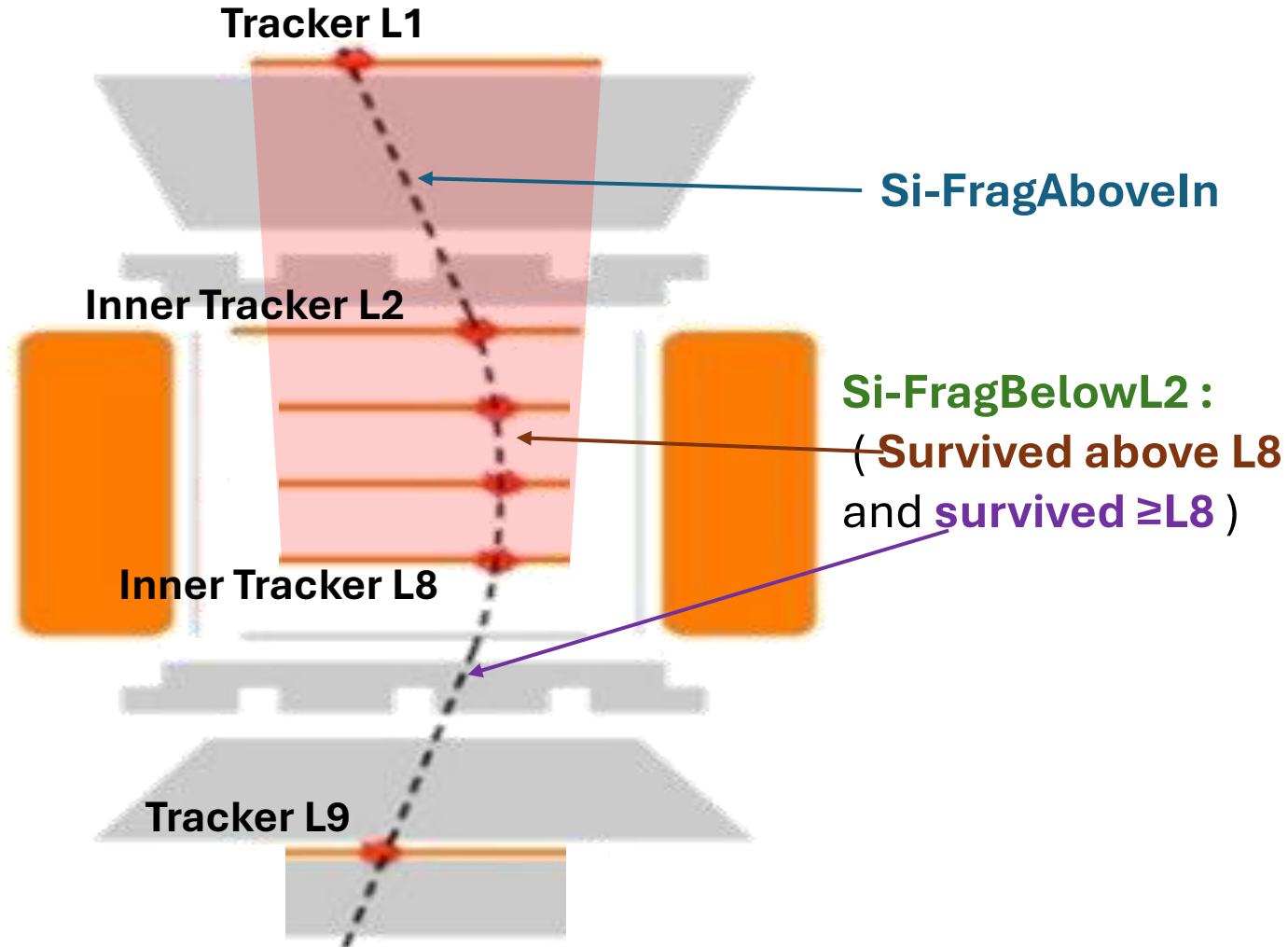
Cons: need more study on the structure of GNN input; Event pre-selection needed.

## Task : Signal background discrimination (with MC samples only for now)

Signal (**Si-FragAboveIn**): primary Si survived below L2

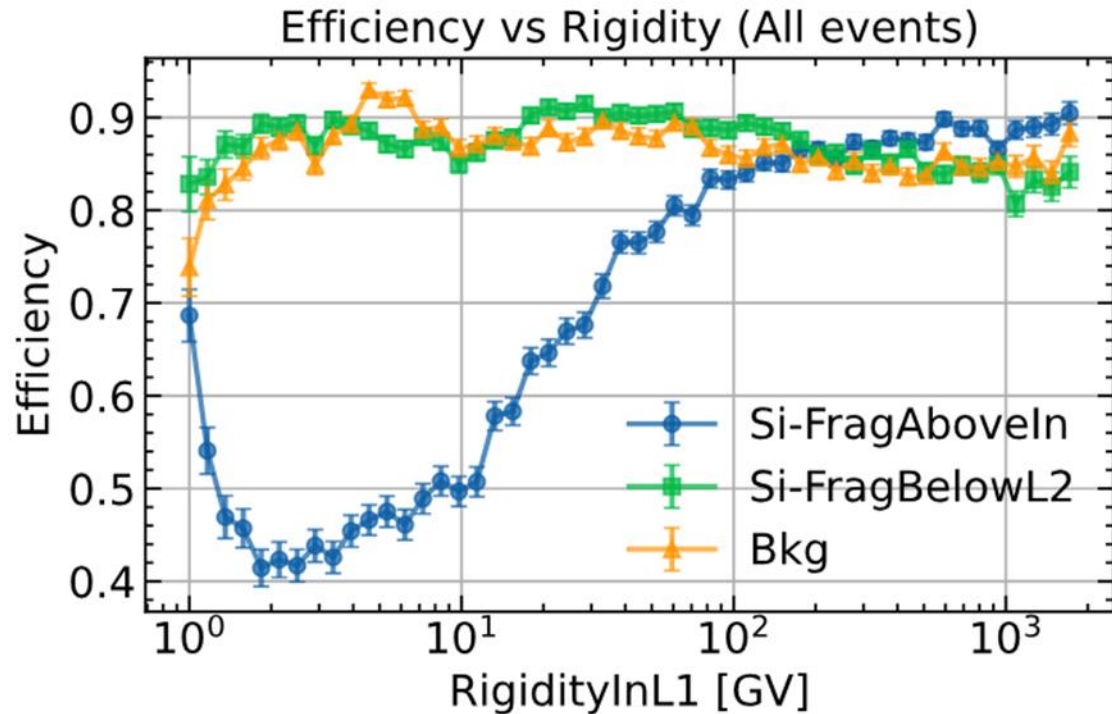
Background 1 (**Si-FragBelowL2**): primary Si survived above L2

Background 2 (**Bkg**): other nuclei (Mg, Al, P, S)

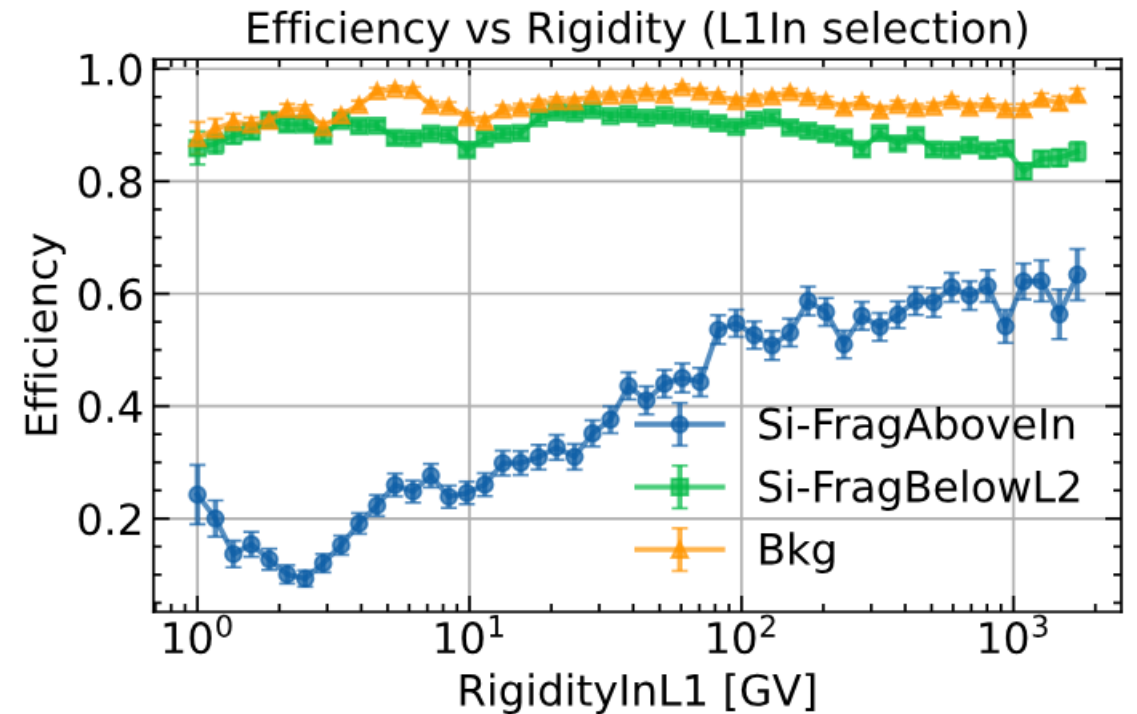


# Model performance: model testing result

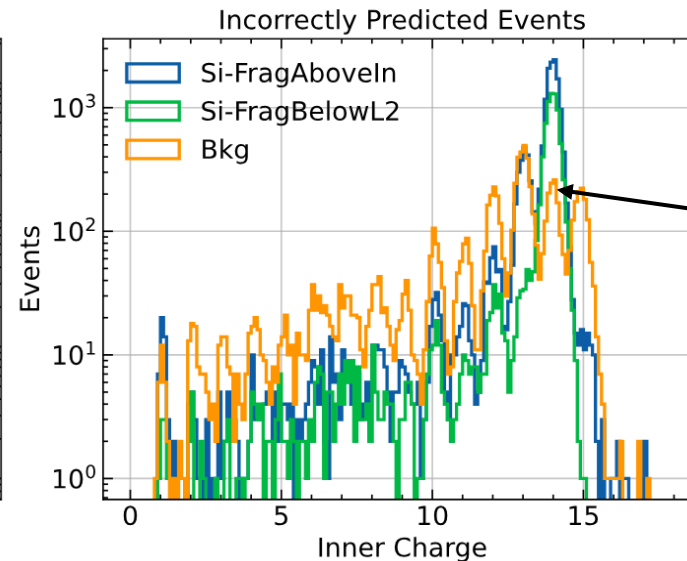
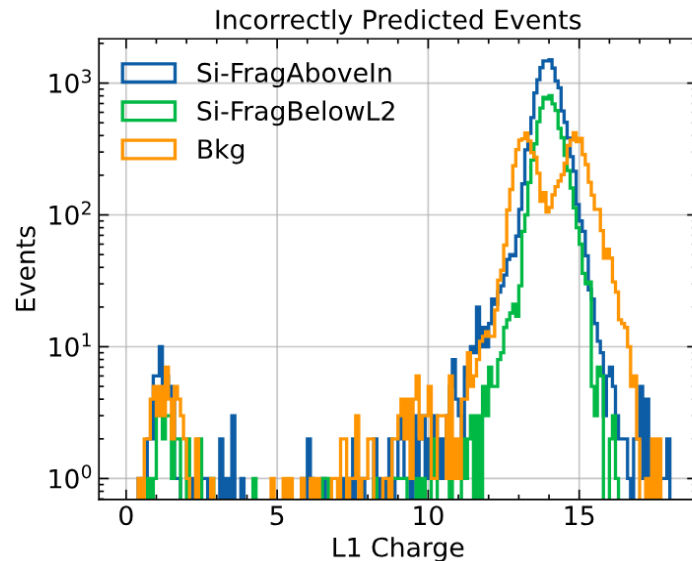
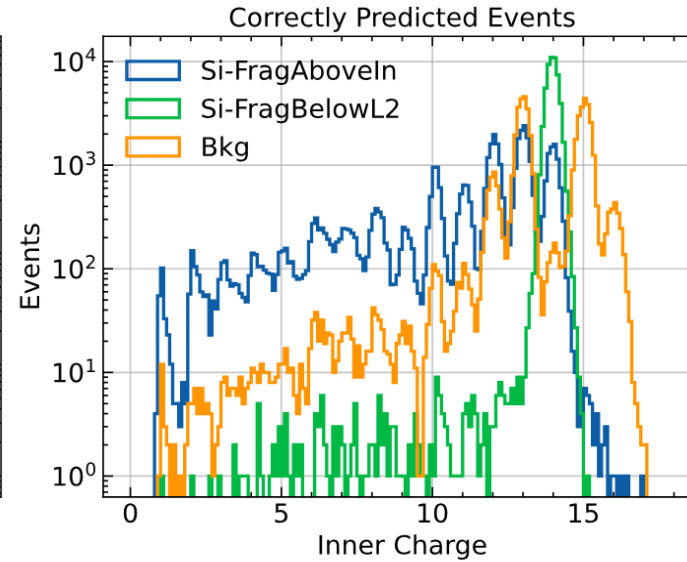
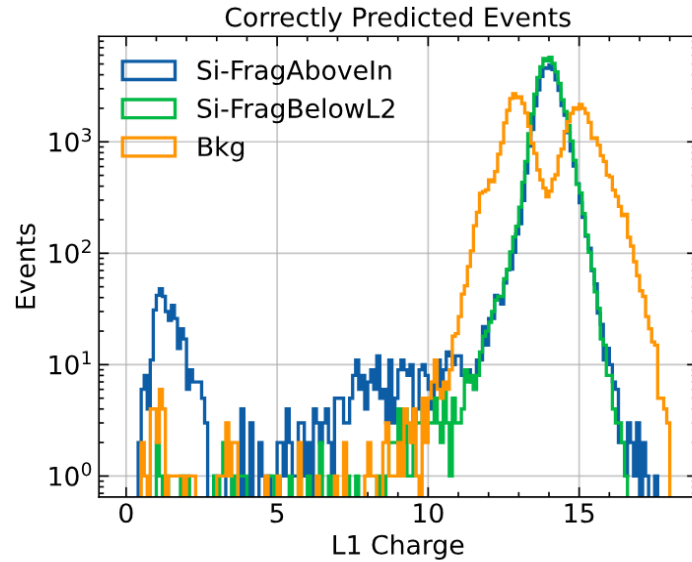
Performance results from all events (i.e. events with ML selection)



Performance results from sample selected with standard nuclei event selection



# Model performance: comparison to standard charge reconstruction results

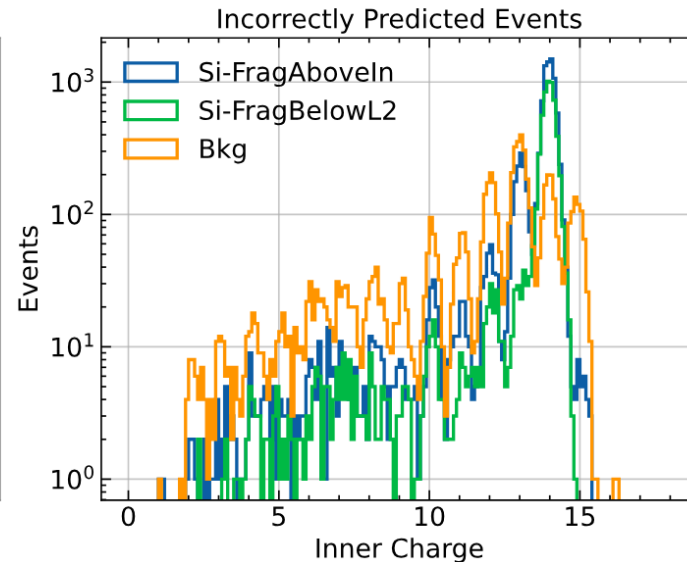
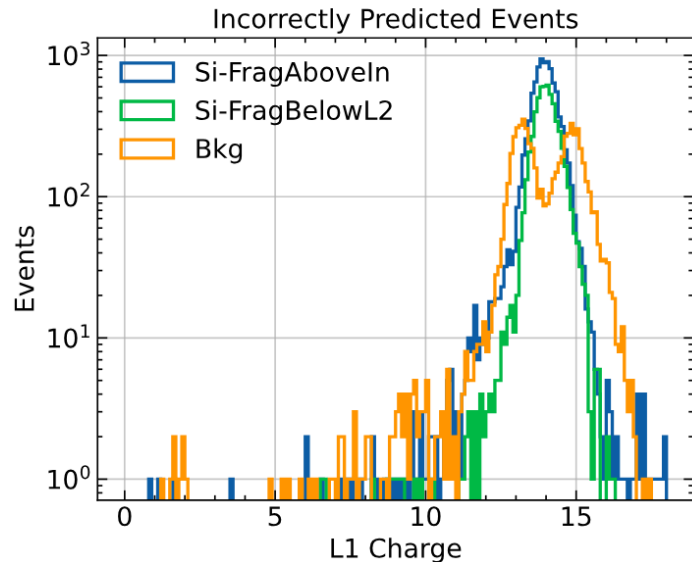
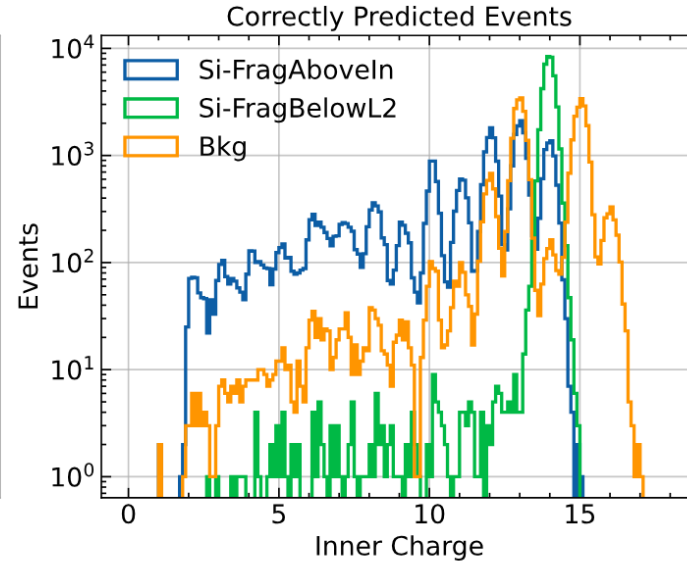
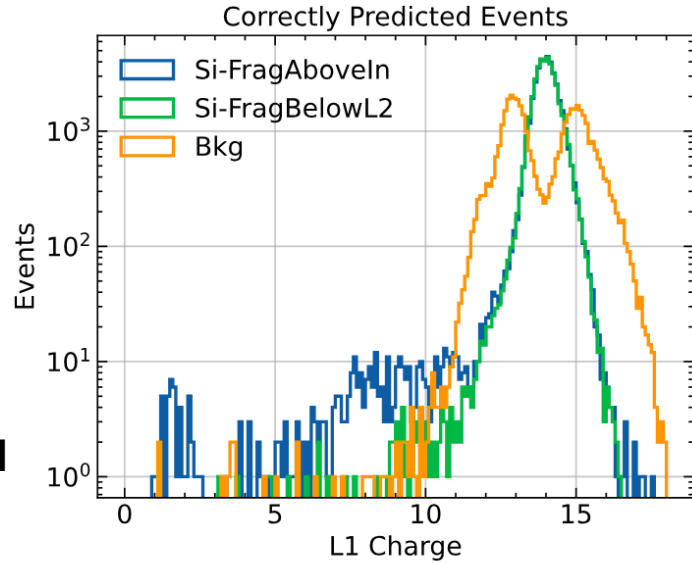


(  
 Low rigidity events:  
 • Small charge  
 • Large ADC  
 • Small number of clusters  
 )

Background nuclei  
 (Mg, Al, P, S) with Inner  
 charge == 14

# Model performance: comparison to standard charge reconstruction results

Test sample selected  
with L1Inner  
Rigidity > 10GV



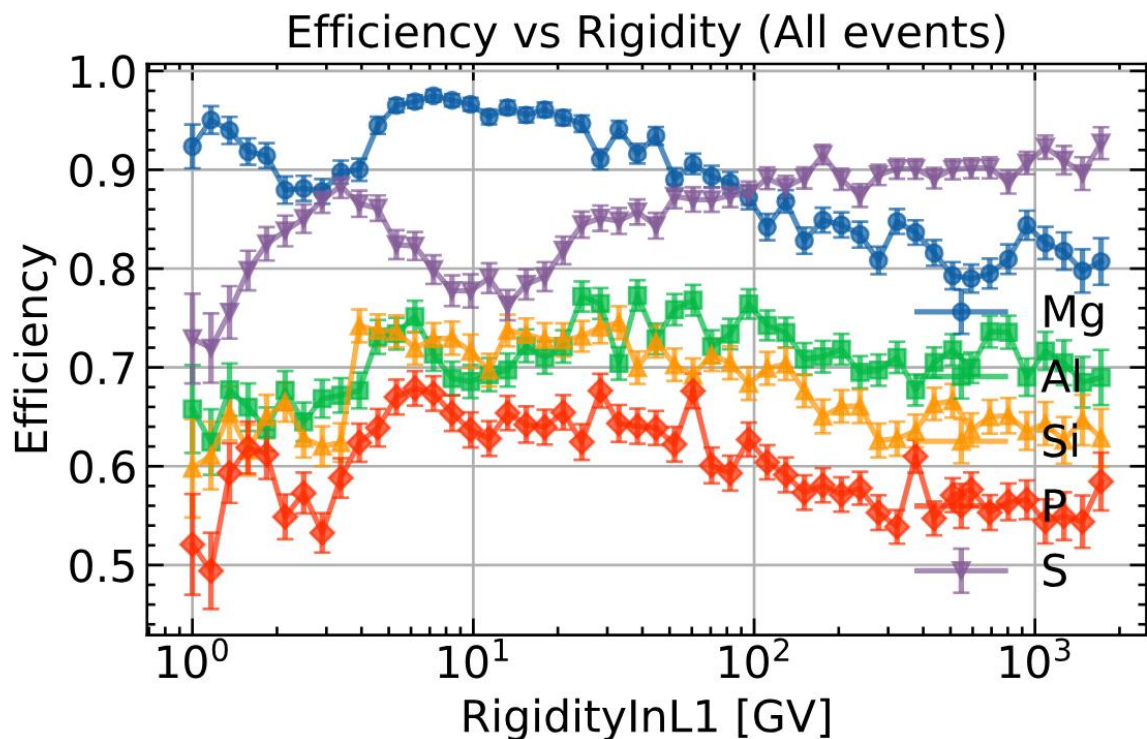


# Optimization plan for Graph construction with ADC information:

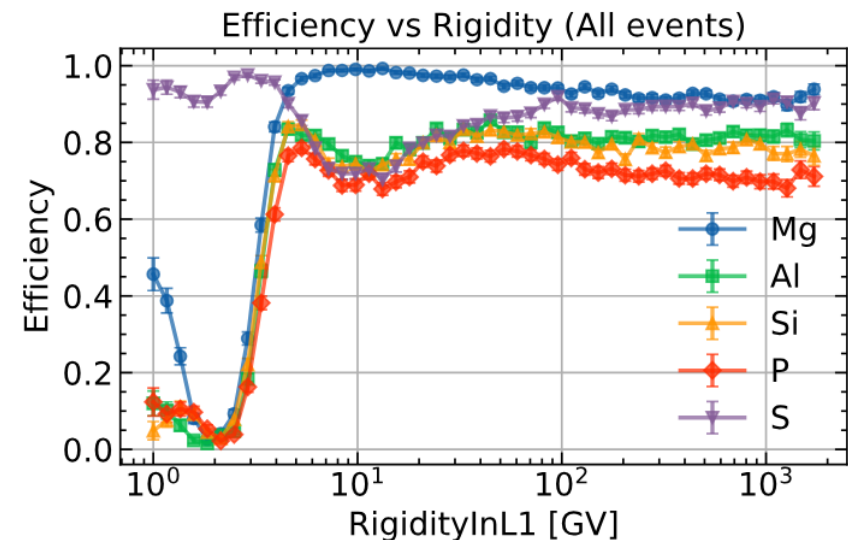
- **Optimization on number of clusters, adjacent strips and edges**
- Instead of connecting nodes based on cluster Edep ranking, → **connect nodes that are physically adjacent based on strip distance**
- Variable number of nodes/edge → **set a threshold based on Edep ratio or distance range**

# Nuclei identification for Mg, Al, Si, P, S

## Results (with clusters and TOF Beta)



## Result (without TOF Beta)



## Standard selection for reference

